

# PSoC™ 4100S Plus 256 KB

Based on Arm® Cortex®-M0+ CPU

## General description

PSoC™ 4 is a scalable and reconfigurable platform architecture for a family of programmable embedded system controllers with an Arm® Cortex®-M0+ CPU. It combines programmable and reconfigurable analog and digital blocks with flexible automatic routing. PSoC™ 4100S Plus 256 KB is a member of the PSoC™ 4 platform architecture. It is a combination of a microcontroller with standard communication and timing peripherals, a capacitive touch-sensing system (CAPSENSE™) with best-in-class performance, programmable general-purpose continuous-time and switched-capacitor analog blocks, and programmable connectivity. PSoC™ 4100S Plus 256 KB products are upward compatible with members of the PSoC™ 4 platform for new applications and design needs.

## Features

- 32-bit MCU subsystem
  - 48 MHz Arm® Cortex®-M0+ CPU with single-cycle multiply
  - Up to 256 KB of flash with read accelerator
  - Up to 32 KB of SRAM
  - 8-channel DMA engine
- Programmable analog
  - Two opamps with reconfigurable high-drive external and high-bandwidth internal drive and comparator modes and ADC input buffering capability. Opamps can operate in Deep Sleep low-power mode
  - 12-bit 1-Msps SAR ADC with differential and single-ended modes, and channel sequencer with signal averaging
  - Single-slope 10-bit ADC function provided by a capacitance sensing block
  - Two current DACs (IDACs) for general-purpose or capacitive sensing applications on any pin
  - Two low-power comparators that operate in Deep Sleep low-power mode
- Programmable digital
  - Programmable logic blocks allowing Boolean operations to be performed on port inputs and outputs
- Low-power 1.71 V to 5.5 V operation
  - Deep Sleep mode with operational analog and 2.5 µA digital system current
- Capacitive sensing
  - Capacitive sigma-delta (CSD) provides best-in-class signal-to-noise ratio (SNR) (>5:1) and water tolerance
  - Infineon-supplied software component makes capacitive sensing design easy
  - Automatic hardware tuning (SmartSense)
- LCD drive capability
  - LCD segment drive capability on GPIOs
- Serial communication
  - Five independent run-time reconfigurable serial communication blocks (SCBs) with re-configurable I<sup>2</sup>C, SPI, or UART functionality
- Timing and pulse-width modulation
  - Eight 16-bit timer/counter/pulse-width modulator (TCPWM) blocks
  - Center-aligned, Edge, and Pseudo-random modes
  - Comparator-based triggering of Kill signals for motor drive and other high-reliability digital logic applications
  - Quadrature decoder

## Features

- Clock sources
  - 4 to 33 MHz external crystal oscillator (ECO)
  - PLL to generate 48 MHz frequency
  - 32 kHz watch crystal oscillator (WCO)
  - $\pm 2\%$  internal main oscillator (IMO)
  - 40 kHz internal low-power oscillator (ILO)
- Up to 57 programmable GPIO pins
  - 48LD TQFP (0.5-mm pitch), and 64 lead TQFP normal (0.8 mm) and 64LD TQFP fine pitch (0.5 mm), and 68 lead QFN (0.5 mm pitch) packages
  - Any GPIO pin can be CAPSENSE™, analog, or digital
  - Drive modes, strengths, and slew rates are programmable
- ModusToolbox™ software
  - Comprehensive collection of multi-platform tools and software libraries
  - Includes board support packages (BSPs), peripheral driver library (PDL), and middleware such as CAPSENSE™
- PSoC™ Creator design environment
  - Integrated development environment (IDE) provides schematic design entry and build, with analog and digital automatic routing
  - Application programming interface (API) components for all fixed-function and programmable peripherals
- Industry-standard tool compatibility
  - After schematic entry, development can be done with Arm®-based industry-standard development tools

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# 1 Development ecosystem

## 1.1 PSoC™ 4 MCU resources

Infineon provides a wealth of data at [www.infineon.com](http://www.infineon.com) to help you select the right PSoC™ device and quickly and effectively integrate it into your design. The following is an abbreviated, hyperlinked list of resources for PSoC™ 4 MCU:

- **Overview: PSoC™ portfolio**
- **Product selectors: PSoC™ 4 MCU**
- **Application notes** cover a broad range of topics, from basic to advanced level, and include the following:
  - **AN79953**: Getting started with PSoC™ 4 MCU
  - **AN88619**: PSoC™ 4 hardware design considerations
  - **AN73854**: Introduction to bootloaders
  - **AN89610**: PSoC™ Arm® Cortex® code optimization
  - **AN86233**: PSoC™ 4 MCU low-power modes and reduction techniques
  - **AN57821**: PSoC™ 3, PSoC™ 4, and PSoC™ 5LP mixed-signal circuit board layout considerations
  - **AN85951**: PSoC™ 4 and PSoC™ 6 MCU CAPSENSE™ design guide
- **Code examples** demonstrate product features and usage, and are also available on [Infineon GitHub repositories](#).
- **Reference manuals** provide detailed descriptions of PSoC™ 4 MCU architecture and registers.
- **PSoC™ 4 MCU programming specification** provides the information necessary to program PSoC™ 4 MCU nonvolatile memory.
- Development tools
  - **ModusToolbox™ software** enables cross platform code development with a robust suite of tools and software libraries.
  - **PSoC™ Creator** is a free Windows-based IDE. It enables concurrent hardware and firmware design of PSoC™ 3, PSoC™ 4, PSoC™ 5LP, and PSoC™ 6 MCU based systems. Applications are created using schematic capture and over 150 pre-verified, production-ready peripheral Components.
  - **CY8CKIT-149** PSoC™ 4100S Plus prototyping kit, is a low-cost and easy-to-use evaluation platform. This kit provides easy access to all the device I/Os in a breadboard-compatible format.
  - **MiniProg4** and **MiniProg3** all-in-one development programmers and debuggers.
  - **PSoC™ 4 MCU CAD libraries** provide footprint and schematic support for common tools. **IBIS models** are also available.
- **Training videos** are available on a wide range of topics including the **PSoC™ 4 MCUs**.
- **Infineon developer community** enables connection with fellow PSoC™ developers around the world, 24 hours a day, 7 days a week, and hosts a dedicated **PSoC™ 4 MCU community**.

## 1.2 ModusToolbox™ software

**ModusToolbox™ software** is Infineon' comprehensive collection of multi-platform tools and software libraries that enable an immersive development experience for creating converged MCU and wireless systems. It is:

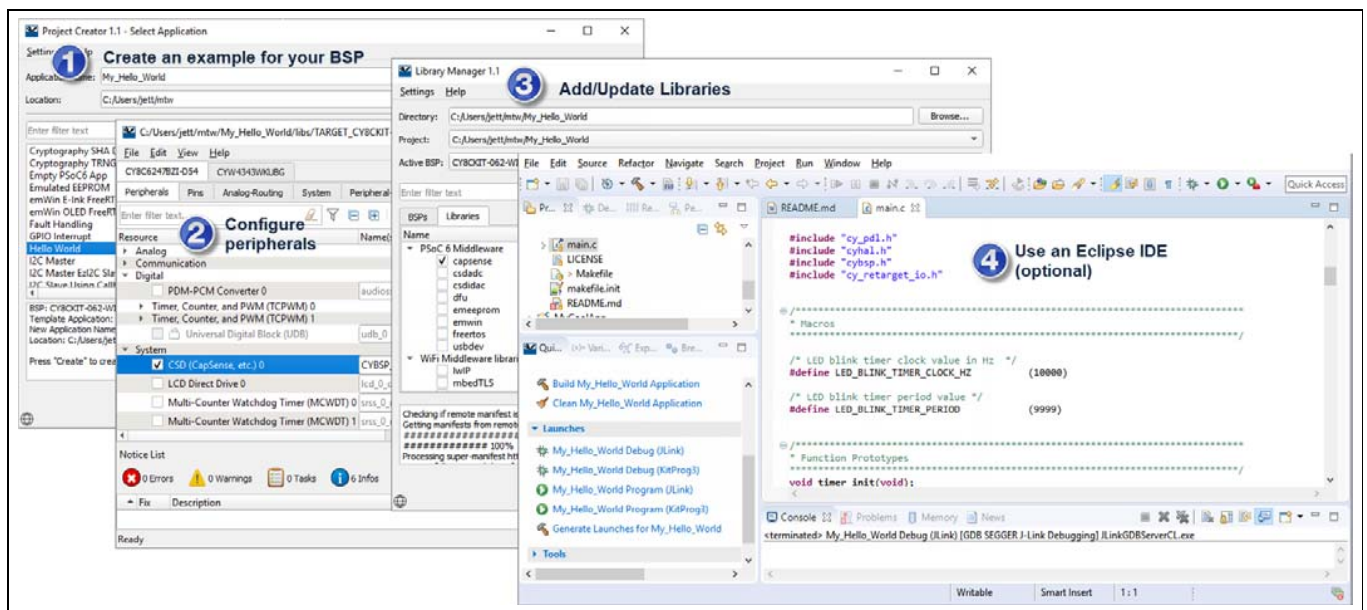
- Comprehensive - it has the resources you need
- Flexible - you can use the resources in your own workflow
- Atomic - you can get just the resources you want

Infineon provides a large collection of code **repositories on GitHub**, including:

- Board support packages (BSPs) aligned with Infineon kits
- Low-level resources, including a peripheral driver library (PDL)
- Middleware enabling industry-leading features such as CAPSENSE™
- An extensive set of thoroughly tested **code example applications**

ModusToolbox™ software is IDE-neutral and easily adaptable to your workflow and preferred development environment. It includes a project creator, peripheral and library configurators, a library manager, as well as the optional Eclipse IDE for ModusToolbox™, as shown in **Figure 1**.

For information on using Infineon tools, refer to the documentation delivered with ModusToolbox™ software, and **AN79953 - Getting started with PSoC™ 4 MCU**.



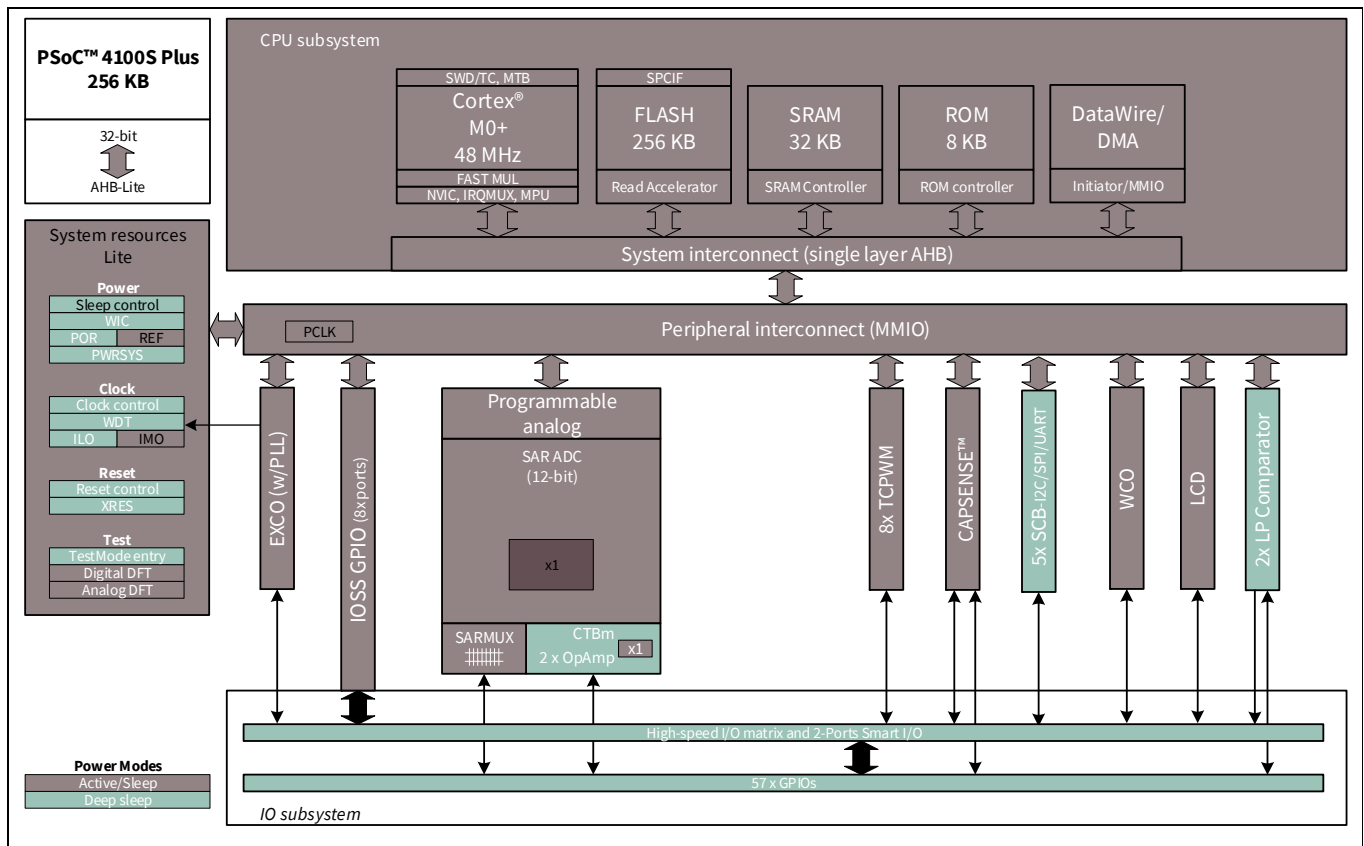
**Figure 1** ModusToolbox™ software tools





Block diagram

## Block diagram



This device includes extensive support for programming, testing, debugging, and tracing both hardware and firmware.

The Arm® serial wire debug (SWD) interface supports all programming and debug features of the device.

Complete debug-on-chip functionality enables full-device debugging in the final system using the standard production device. It does not require special interfaces, debugging pods, simulators, or emulators. Only the standard programming connections are required to fully support debug.

The PSoC™ Creator IDE provides fully integrated programming and debug support for this device. The SWD interface is fully compatible with industry-standard third-party tools. This device provides a level of security not possible with multi-chip application solutions or with microcontrollers. It has the following advantages:

- Allows disabling of debug features
- Robust flash protection
- Allows customer-proprietary functionality to be implemented in on-chip programmable blocks

The debug circuits are enabled by default and can be disabled in firmware. If they are not enabled, the only way to re-enable them is to erase the entire device, clear flash protection, and reprogram the device with new firmware that enables debugging. Thus firmware control of debugging cannot be over-riden without erasing the firmware thus providing security.

Additionally, all device interfaces can be permanently disabled (device security) for applications concerned about phishing attacks due to a maliciously reprogrammed device or attempts to defeat security by starting and interrupting flash programming sequences. All programming, debug, and test interfaces are disabled when maximum device security is enabled. Therefore, this device, with device security enabled, may not be returned for failure analysis. This is a trade-off it allows the customer to make.

## **2 Functional definition**

### **2.1 CPU and memory subsystem**

#### **2.1.1 CPU**

The Cortex®-M0+ CPU in PSoC™ 4100S Plus 256 KB is part of the 32-bit MCU subsystem, which is optimized for low-power operation with extensive clock gating. Most instructions are 16 bits in length and the CPU executes a subset of the Thumb-2 instruction set. It includes a nested vectored interrupt controller (NVIC) block with eight interrupt inputs and also includes a wakeup interrupt controller (WIC). The WIC can wake the processor from Deep Sleep mode, allowing power to be switched off to the main processor when the chip is in Deep Sleep mode. The CPU subsystem includes an 8-channel DMA engine and also includes a debug interface, the serial wire debug (SWD) interface, which is a two-wire form of JTAG. The debug configuration used for PSoC™ 4100S Plus 256 KB has four breakpoint (address) comparators and two watchpoint (data) comparators.

#### **2.1.2 Flash**

The PSoC™ 4100S Plus 256 KB device has a 256 KB flash module with a flash accelerator, tightly coupled to the CPU to improve average access times from the flash block. The low-power flash block is designed to deliver two wait-state (WS) access time at 48 MHz. The flash accelerator delivers 85% of single-cycle SRAM access performance on average.

#### **2.1.3 SRAM**

32 KB of SRAM are provided with zero wait-state access at 48 MHz.

#### **2.1.4 SROM**

An 8-KB supervisory ROM that contains boot and configuration routines is provided.

### **2.2 System resources**

#### **2.2.1 Power system**

The power system is described in detail in the section [Power](#). It provides assurance that voltage levels are as required for each respective mode and either delays mode entry (for example, on power-on reset (POR)) until voltage levels are as required for proper functionality, or generates resets (for example, on brown out detection). operates with a single external supply over the range of either 1.8 V ±5% (externally regulated) or 1.8 to 5.5 V (internally regulated) and has three different power modes, transitions between which are managed by the power system. PSoC™ 4100S Plus 256 KB provides Active, Sleep, and Deep Sleep low-power modes.

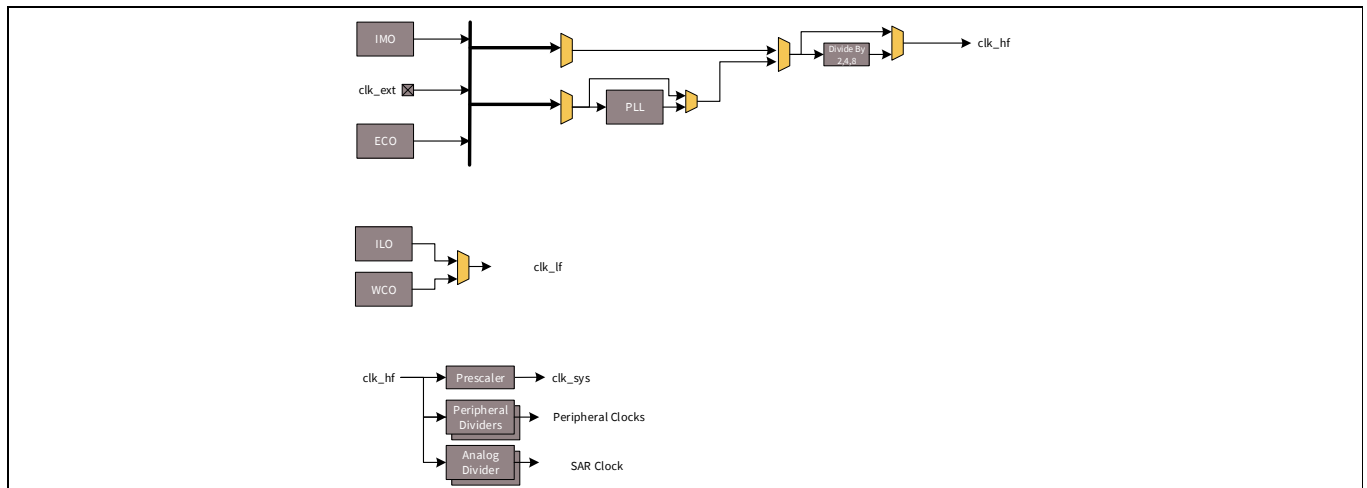
All subsystems are operational in active mode. The CPU subsystem (CPU, flash, and SRAM) is clock-gated OFF in Sleep mode, while all peripherals and interrupts are active with instantaneous wake-up on a wake-up event. In Deep Sleep mode, the high-speed clock and associated circuitry is switched OFF; wakeup from this mode takes 35 μs. The opamps can remain operational in Deep Sleep mode.



## 2.2.2 Clock system

The PSoC™ 4100S Plus 256 KB clock system is responsible for providing clocks to all subsystems that require clocks and for switching between different clock sources without glitching. In addition, the clock system ensures that there are no metastable conditions.

The clock system for the PSoC™ 4100S Plus 256 KB consists of the IMO, ILO, a 32 kHz WCO, ECO, and PLL, and provision for an external clock. The WCO block allows locking the IMO to the 32 kHz oscillator.



**Figure 3** MCU clocking architecture

The HFCLK signal can be divided down as shown to generate synchronous clocks for the analog and digital peripherals. There are 18 clock dividers for the PSoC™ 4100S Plus 256 KB (six with fractional divide capability, twelve with integer divide only). There are twelve 16-bit dividers allowing a lot of flexibility in generating fine-grained frequencies.

In addition, there are five 16-bit fractional dividers and one 24-bit fractional divider.

## 2.2.3 IMO clock source

The IMO is the primary source of internal clocking in the PSoC™ 4100S Plus 256 KB. It is trimmed during testing to achieve the specified accuracy. The IMO default frequency is 24 MHz and it can be adjusted from 24 to 48 MHz in steps of 4 MHz. The IMO tolerance with Infineon-provided calibration settings is  $\pm 2\%$  over the entire voltage and temperature range.

## 2.2.4 ILO clock source

The ILO is a very low power, nominally 40 kHz oscillator, which is primarily used to generate clocks for the watchdog timer (WDT) and peripheral operation in Deep Sleep mode. ILO-driven counters can be calibrated to the IMO to improve accuracy. Infineon provides a software component, which does the calibration.

## 2.2.5 Watch crystal oscillator (WCO)

The PSoC™ 4100S Plus 256 KB clock subsystem also implements a low-frequency (32 kHz watch crystal) oscillator that can be used for precision timing applications. The WCO block allows locking the IMO to the 32 kHz oscillator.

## 2.2.6 External crystal oscillators (ECO)

The PSoC™ 4100S Plus 256 KB also implements a 4 to 33 MHz crystal oscillator.

## 2.2.7 Watchdog timer and counters

A watchdog timer is implemented in the clock block running from the ILO; this allows watchdog operation during Deep Sleep and generates a watchdog reset if not serviced before the set timeout occurs. The watchdog reset is recorded in a Reset cause register, which is firmware readable. The watchdog counters can be used to implement a Real-Time clock using the 32 kHz WCO.

## 2.2.8 Reset

PSoC™ 4100S Plus 256 KB can be reset from a variety of sources including a software reset. Reset events are asynchronous and guarantee reversion to a known state. The reset cause is recorded in a register, which is sticky through reset and allows software to determine the cause of the reset. An XRES pin is reserved for external reset by asserting it active low. The XRES pin has an internal pull-up resistor that is always enabled.

## 2.3 Analog blocks

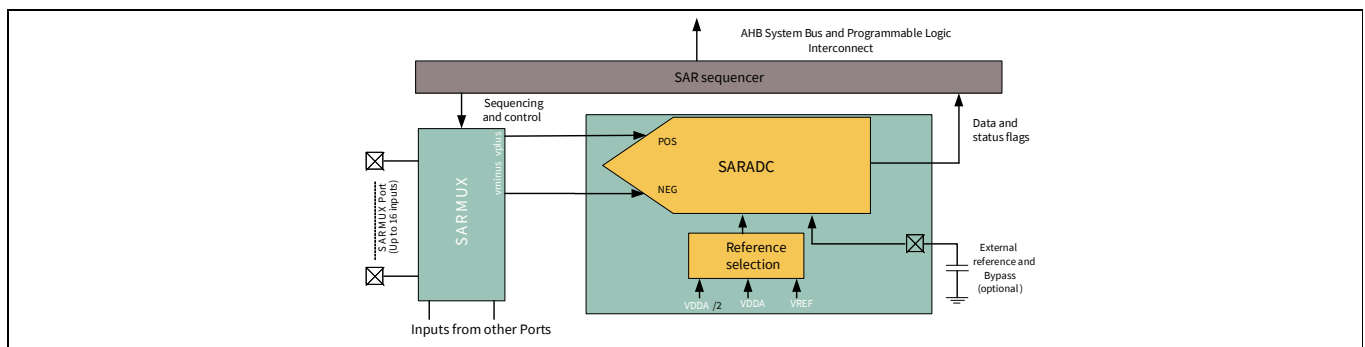
### 2.3.1 12-bit SAR ADC

The 12-bit, 1-Msps SAR ADC can operate at a maximum clock rate of 18 MHz and requires a minimum of 18 clocks to do a 12-bit conversion.

The sample-and-hold (S/H) aperture is programmable allowing the gain bandwidth requirements of the amplifier driving the SAR inputs, which determine its settling time, to be relaxed if required. It is possible to provide an external bypass (through a fixed pin location) for the internal reference amplifier.

The SAR is connected to a fixed set of pins through an 8-input sequencer. The sequencer cycles through selected channels autonomously (sequencer scan) with zero switching overhead (that is, aggregate sampling bandwidth is equal to 1 Msps whether it is for a single channel or distributed over several channels). The sequencer switching is effected through a state machine or through firmware driven switching. A feature provided by the sequencer is buffering of each channel to reduce CPU interrupt service requirements. To accommodate signals with varying source impedance and frequency, it is possible to have different sample times programmable for each channel. Also, signal range specification through a pair of range registers (low and high range values) is implemented with a corresponding out-of-range interrupt if the digitized value exceeds the programmed range; this allows fast detection of out-of-range values without the necessity of having to wait for a sequencer scan to be completed and the CPU to read the values and check for out-of-range values in software.

The SAR is not available in Deep Sleep mode as it requires a high-speed clock (up to 18 MHz). The SAR operating range is 1.71 V to 5.5 V.



**Figure 4 SAR ADC**

### 2.3.2 Opamps (continuous-time block; CTB)

PSoC™ 4100S Plus 256 KB has two opamps with comparator modes which allow most common analog functions to be performed on-chip eliminating external components; PGAs, voltage buffers, filters, TransImpedance Amplifiers, and other functions can be realized, in some cases with external passives. saving power, cost, and space. The on-chip opamps are designed with enough bandwidth to drive the Sample-and-Hold circuit of the ADC without requiring external buffering.

### 2.3.3 Low-power comparators (LPC)

PSoC™ 4100S Plus 256 KB has a pair of low-power comparators, which can also operate in low-power modes. This allows the analog system blocks to be disabled while retaining the ability to monitor external voltage levels during low-power modes. The comparator outputs are normally synchronized to avoid metastability unless operating in an asynchronous Power mode where the system wake-up circuit is activated by a comparator switch event. The LPC outputs can be routed to pins.

### 2.3.4 Current DACs

PSoC™ 4100S Plus 256 KB has two 7-bit IDACs, which can drive any of the pins on the chip. These IDACs have programmable current ranges.

### 2.3.5 Analog multiplexed buses

PSoC™ 4100S Plus 256 KB has two concentric independent buses that go around the periphery of the chip. These buses (called amux buses) are connected to firmware-programmable analog switches that allow the chip's internal resources (IDACs, comparator) to connect to any pin on the I/O ports.

## 2.4 Programmable digital blocks

### 2.4.1 Smart I/O block

The Smart I/O block is a fabric of switches and LUTs that allows boolean functions to be performed in signals being routed to the pins of a GPIO port. The Smart I/O can perform logical operations on input pins to the chip and on signals going out as outputs. There are two Smart I/O blocks in the PSoC™ 4100S Plus 256 KB.

## 2.5 Fixed function digital blocks

### 2.5.1 Timer, Counter, Pulse-width modulator (TCPWM) block

The TCPWM block consists of a 16-bit counter with user-programmable period length. There is a capture register to record the count value at the time of an event (which may be an I/O event), a period register that is used to either stop or auto-reload the counter when its count is equal to the period register, and compare registers to generate compare value signals that are used as PWM duty cycle outputs. The block also provides true and complementary outputs with programmable offset between them to allow use as dead-band programmable complementary PWM outputs. It also has a Kill input to force outputs to a predetermined state; for example, this is used in motor drive systems when an over-current state is indicated and the PWM driving the FETs needs to be shut off immediately with no time for software intervention. Each block also incorporates a Quadrature decoder. There are eight TCPWM blocks in PSoC™ 4100S Plus 256 KB.

### 2.5.2 Serial communication block (SCB)

PSoC™ 4100S Plus 256 KB has five serial communication blocks, which can be programmed to have SPI, I<sup>2</sup>C, or UART functionality.

- **I<sup>2</sup>C mode:** The hardware I<sup>2</sup>C block implements a full multi-master and slave interface (it is capable of multi-master arbitration). This block is capable of operating at speeds of up to 400 kbps (Fast mode) and has flexible buffering options to reduce interrupt overhead and latency for the CPU. It also supports EZI<sup>2</sup>C that creates a mailbox address range in the memory of PSoC™ 4100S Plus 256 KB and effectively reduces I<sup>2</sup>C communication to reading from and writing to an array in memory. In addition, the block supports an 8-deep FIFO for receive and transmit which, by increasing the time given for the CPU to read data, greatly reduces the need for clock stretching caused by the CPU not having read data on time.

The I<sup>2</sup>C peripheral is compatible with the I<sup>2</sup>C Standard mode and Fast mode devices as defined in the NXP I<sup>2</sup>C-bus specification and user manual (UM10204). The I<sup>2</sup>C bus I/O is implemented with GPIO in open-drain modes.

PSoC™ 4100S Plus 256 KB is not completely compliant with the I<sup>2</sup>C spec in the following respect:

- GPIO cells are not overvoltage tolerant; therefore, cannot be hot-swapped or powered up independently of the rest of the I<sup>2</sup>C system.
- **UART mode:** This is a full-feature UART operating at up to 1 Mbps. It supports automotive single-wire interface (LIN), infrared interface (IrDA), and SmartCard (ISO7816) protocols, all of which are minor variants of the basic UART protocol. In addition, it supports the 9-bit multiprocessor mode that allows addressing of peripherals connected over common RX and TX lines. Common UART functions such as parity error, break detect, and frame error are supported. An 8-deep FIFO allows much greater CPU service latencies to be tolerated.
- **SPI mode:** The SPI mode supports full Motorola SPI, TI SSP (adds a start pulse used to synchronize SPI Codecs), and National Microwire (half-duplex form of SPI). The SPI block can use the FIFO.

## 2.6 GPIO

PSoC™ 4100S Plus 256 KB has up to 57 GPIOs. The GPIO block implements the following:

- Eight drive modes:
  - Analog input mode (input and output buffers disabled)
  - Input only
  - Weak pull-up with strong pull-down
  - Strong pull-up with weak pull-down
  - Open drain with strong pull-down
  - Open drain with strong pull-up
  - Strong pull-up with strong pull-down
  - Weak pull-up with weak pull-down
- Input threshold select (CMOS or LVTTTL)
- Individual control of input and output buffer enabling/disabling in addition to the drive strength modes
- Selectable slew rates for dV/dt related noise control to improve EMI

The pins are organized in logical entities called ports, which are 8-bit in width (less for Ports 5 and 6). During power-on and reset, the blocks are forced to the disable state so as not to crowbar any inputs and/or cause excess turn-on current. A multiplexing network known as a high-speed I/O matrix is used to multiplex between various signals that may connect to an I/O pin.

Data output and pin state registers store, respectively, the values to be driven on the pins and the states of the pins themselves.

Every I/O pin can generate an interrupt if so enabled and each I/O port has an interrupt request (IRQ) and interrupt service routine (ISR) vector associated with it.

## 2.7 Special function peripherals

### 2.7.1 CAPSENSE™

CAPSENSE™ is supported in the PSoC™ 4100S Plus 256 KB through a capacitive sigma-delta (CSD) block that can be connected to any pins through an analog multiplex bus via analog switches. CAPSENSE™ function can thus be provided on any available pin or group of pins in a system under software control. A PSoC™ Creator component is provided for the CAPSENSE™ block to make it easy for the user.

Shield voltage can be driven on another analog multiplex bus to provide water-tolerance capability. Water tolerance is provided by driving the shield electrode in phase with the sense electrode to keep the shield capacitance from attenuating the sensed input. Proximity sensing can also be implemented.

The CAPSENSE™ block has two IDACs, which can be used for general purposes if CAPSENSE™ is not being used (both IDACs are available in that case) or if CAPSENSE™ is used without water tolerance (one IDAC is available).

The CAPSENSE™ block also provides a 10-bit slope ADC function which can be used in conjunction with the CAPSENSE™ function.

The CAPSENSE™ block is an advanced, low-noise, programmable block with programmable voltage references and current source ranges for improved sensitivity and flexibility. It can also use an external reference voltage. It has a full-wave CSD mode that alternates sensing to VDDA and ground to null out power-supply related noise.

### 2.7.2 LCD segment drive

PSoC™ 4100S Plus 256 KB has an LCD controller, which can drive up to 4 commons and up to 50 segments. Any pin can be either a common or a segment pin. It uses full digital methods to drive the LCD segments requiring no generation of internal LCD voltages. The two methods used are referred to as digital image correlation and PWM. Digital image correlation pertains to modulating the frequency and drive levels of the common and segment signals to generate the highest RMS voltage across a segment to light it up or to keep the RMS signal to zero. This method is good for STN displays but may result in reduced contrast with TN (cheaper) displays. PWM pertains to driving the panel with PWM signals to effectively use the capacitance of the panel to provide the integration of the modulated pulse-width to generate the desired LCD voltage. This method results in higher power consumption but can result in better results when driving TN displays.

### 3 Pinouts

The following table provides the pin list for PSoC™ 4100S Plus 256 KB for the 48LD TQFP and 64LD TQFP normal and 64 lead fine pitch packages, and 68 lead QFN packages.

**Table 1 Pinout**

64LD TQFP		48LD TQFP		68 lead QFN	
Pin	Name	Pin	Name	Pin	Name
39	P0.0	28	P0.0	42	P0.0
40	P0.1	29	P0.1	43	P0.1
41	P0.2	30	P0.2	44	P0.2
42	P0.3	31	P0.3	45	P0.3
43	P0.4	32	P0.4	46	P0.4
44	P0.5	33	P0.5	47	P0.5
45	P0.6	34	P0.6	48	P0.6
46	P0.7	35	P0.7	49	P0.7
47	XRES	36	XRES	50	XRES
48	VCCD	37	VCCD	51	VCCD
49	VSSD	38	VSSD	52	VSSD
50	VDDD	39	VDDD	53	VDDD
51	P5.0	-	-	54	P5.0
52	P5.1	-	-	55	P5.1
53	P5.2	-	-	56	P5.2
54	P5.3	-	-	57	P5.3
-	-	-	-	58	P5.4
55	P5.5	-	-	59	P5.5
56	VDDA	40	VDDA	60	VDDA
57	VSSA	41	VSSA	61	VSSA
58	P1.0	42	P1.0	62	P1.0
59	P1.1	43	P1.1	63	P1.1
60	P1.2	44	P1.2	64	P1.2
61	P1.3	45	P1.3	65	P1.3
62	P1.4	46	P1.4	66	P1.4
63	P1.5	47	P1.5	67	P1.5
64	P1.6	48	P1.6	68	P1.6
1	P1.7	1	P1.7	1	P1.7
2	P2.0	2	P2.0	2	P2.0
3	P2.1	3	P2.1	3	P2.1
4	P2.2	4	P2.2	4	P2.2
5	P2.3	5	P2.3	5	P2.3
6	P2.4	6	P2.4	6	P2.4

**Note**

1. DNC = Do not connect. No connection should be made to this pin.

Pinouts

**Table 1** Pinout (continued)

64LD TQFP		48LD TQFP		68 lead QFN	
Pin	Name	Pin	Name	Pin	Name
7	P2.5	7	P2.5	7	P2.5
8	P2.6	8	P2.6	8	P2.6
9	P2.7	9	P2.7	9	P2.7
10	VSSD	10	VSSD	10	VSSD
11	*DNC <sup>[1]</sup>	11	*DNC <sup>[1]</sup>	11	*DNC <sup>[1]</sup>
-	-	15	*DNC <sup>[1]</sup>	-	-
12	P6.0	-	-	12	P6.0
13	P6.1	-	-	13	P6.1
14	P6.2	-	-	14	P6.2
-	-	-	-	15	P6.3
15	P6.4	-	-	16	P6.4
16	P6.5	-	-	17	P6.5
17	VSSD	-	-	18	VSSD
18	P3.0	12	P3.0	19	P3.0
19	P3.1	13	P3.1	20	P3.1
20	P3.2	14	P3.2	21	P3.2
21	P3.3	16	P3.3	22	P3.3
22	P3.4	17	P3.4	23	P3.4
23	P3.5	18	P3.5	24	P3.5
24	P3.6	19	P3.6	25	P3.6
25	P3.7	20	P3.7	26	P3.7
26	VDDD	21	VDDD	27	VDDD
27	P4.0	22	P4.0	28	P4.0
28	P4.1	23	P4.1	29	P4.1
29	P4.2	24	P4.2	30	P4.2
30	P4.3	25	P4.3	31	P4.3
31	P4.4	-	-	32	P4.4
32	P4.5	-	-	33	P4.5
33	P4.6	-	-	34	P4.6
34	P4.7	-	-	35	P4.7
35	P5.6	-	-	36	P5.6
36	P5.7	-	-	37	P5.7
-	-	-	-	38	*DNC <sup>[1]</sup>
37	P7.0	26	P7.0	39	P7.0
38	P7.1	27	P7.1	40	P7.1
-	-	-	-	41	P7.2

**Note**

1. DNC = Do not connect. No connection should be made to this pin.



Pinouts

**Descriptions of the power pins are as follows:**

VDDD: Power supply for the digital section

VDDA: Power supply for the analog section

VSSD, VSSA: Ground pins for the digital and analog sections respectively

VCCD: Regulated digital supply (1.8 V ±5%)

**GPIOs by package:**

	<b>68 lead QFN</b>	<b>64 LD TQFP</b>	<b>48LD TQFP</b>
<b>Number</b>	57	54	38

### 3.1 Alternate pin functions

Each Port pin has can be assigned to one of multiple functions; it can, for example, be an analog I/O, a digital peripheral function, an LCD pin, or a CAPSENSE™ pin. The pin assignments are shown in the following table.

**Table 2** Alternate pin functions

Port/pin	Analog	Smart I/O	ACT #0	ACT #1	ACT #3	DS #2	DS #3
P0.0	lpcomp.in_p[0]	-	-	tcpwm.tr_in[0]	scb[2].uart_cts:0	scb[2].i2c_scl:0	scb[0].spi_select1:0
P0.1	lpcomp.in_n[0]	-	-	tcpwm.tr_in[1]	scb[2].uart_rts:0	scb[2].i2c_sda:0	scb[0].spi_select2:0
P0.2	lpcomp.in_p[1]	-	-	-	-	-	scb[0].spi_select3:0
P0.3	lpcomp.in_n[1]	-	-	-	-	-	scb[2].spi_select0:1
P0.4	wco.wco_in	-	-	scb[1].uart_rx:0	scb[2].uart_rx:0	scb[1].i2c_scl:0	scb[1].spi_mosi:1
P0.5	wco.wco_out	-	-	scb[1].uart_tx:0	scb[2].uart_tx:0	scb[1].i2c_sda:0	scb[1].spi_miso:1
P0.6	exco.eco_in	-	ext_clk:0	scb[1].uart_cts:0	scb[2].uart_tx:1	-	scb[1].spi_clk:1
P0.7	exco.eco_out	-	tcpwm.line[0]:3	scb[1].uart_rts:0	-	-	scb[1].spi_select0:1
P5.0	-	-	tcpwm.line[4]:2	-	-	scb[2].i2c_scl:1	scb[2].spi_mosi:0
P5.1	-	-	tcpwm.line_compl[4]:2	-	scb[2].uart_tx:2	scb[2].i2c_sda:1	scb[2].spi_miso:0
P5.2	-	-	tcpwm.line[5]:2	-	scb[2].uart_cts:1	lpcomp.comp[0]:2	scb[2].spi_clk:0
P5.3	-	-	tcpwm.line_compl[5]:2	-	scb[2].uart_rts:1	lpcomp.comp[1]:0	scb[2].spi_select0:0
P5.4	-	-	tcpwm.line[6]:2	-	-	-	scb[2].spi_select1:0
P5.5	-	-	tcpwm.line_compl[6]:2	-	-	-	scb[2].spi_select2:0
P1.0	ctb0_oa0+	-	tcpwm.line[2]:1	scb[0].uart_rx:1	-	scb[0].i2c_scl:0	scb[0].spi_mosi:1
P1.1	ctb0_oa0-	-	tcpwm.line_compl[2]:1	scb[0].uart_tx:1	-	scb[0].i2c_sda:0	scb[0].spi_miso:1



**Table 2** Alternate pin functions (continued)

Port/pin	Analog	Smart I/O	ACT #0	ACT #1	ACT #3	DS #2	DS #3
P1.2	ctb0_oa0_out	-	tcpwm.line[3]:1	scb[0].uart_cts:1	tcpwm.tr_in[2]	scb[2].i2c_scl:2	scb[0].spi_clk:1
P1.3	ctb0_oa1_out	-	tcpwm.line_compl[3]:1	scb[0].uart_rts:1	tcpwm.tr_in[3]	scb[2].i2c_sda:2	scb[0].spi_select0:1
P1.4	ctb0_oa1-	-	tcpwm.line[6]:1	-	-	scb[3].i2c_scl:0	scb[0].spi_select1:1
P1.5	ctb0_oa1+	-	tcpwm.line_compl[6]:1	-	-	scb[3].i2c_sda:0	scb[0].spi_select2:1
P1.6	ctb0_oa0+	-	tcpwm.line[7]:1	-	-	-	scb[0].spi_select3:1
P1.7	ctb0_oa1+ sar_ext_vref0 sar_ext_vref1	-	tcpwm.line_compl[7]:1	-	-	-	scb[2].spi_clk:1
P2.0	sarmux[0]	Smartlo[0].io[0]	tcpwm.line[4]:0	csd.comp	tcpwm.tr_in[4]	scb[1].i2c_scl:1	scb[1].spi_mosi:2
P2.1	sarmux[1]	Smartlo[0].io[1]	tcpwm.line_compl[4]:0	-	tcpwm.tr_in[5]	scb[1].i2c_sda:1	scb[1].spi_miso:2
P2.2	sarmux[2]	Smartlo[0].io[2]	tcpwm.line[5]:1	-	-	-	scb[1].spi_clk:2
P2.3	sarmux[3]	Smartlo[0].io[3]	tcpwm.line_compl[5]:1	-	-	-	scb[1].spi_select0:2
P2.4	sarmux[4]	Smartlo[0].io[4]	tcpwm.line[0]:1	scb[3].uart_rx:1	-	-	scb[1].spi_select1:1
P2.5	sarmux[5]	Smartlo[0].io[5]	tcpwm.line_compl[0]:1	scb[3].uart_tx:1	-	-	scb[1].spi_select2:1
P2.6	sarmux[6]	Smartlo[0].io[6]	tcpwm.line[1]:1	scb[3].uart_cts:1	-	-	scb[1].spi_select3:1
P2.7	sarmux[7]	Smartlo[0].io[7]	tcpwm.line_compl[1]:1	scb[3].uart_rts:1	-	lpcomp.comp[0]:0	scb[2].spi_mosi:1
P6.0	-	-	tcpwm.line[4]:1	scb[3].uart_rx:0	-	scb[3].i2c_scl:1	scb[3].spi_mosi:0
P6.1	-	-	tcpwm.line_compl[4]:1	scb[3].uart_tx:0	-	scb[3].i2c_sda:1	scb[3].spi_miso:0
P6.2	-	-	tcpwm.line[5]:0	scb[3].uart_cts:0	-	-	scb[3].spi_clk:0



**Table 2**      **Alternate pin functions** *(continued)*

Port/pin	Analog	Smart I/O	ACT #0	ACT #1	ACT #3	DS #2	DS #3
P6.3	-	-	tcpwm.line_compl[5]:0	scb[3].uart_rts:0	-	-	scb[3].spi_select0:0
P6.4	-	-	tcpwm.line[6]:0	-	-	scb[4].i2c_scl	scb[3].spi_select1:0
P6.5	-	-	tcpwm.line_compl[6]:0	-	-	scb[4].i2c_sda	scb[3].spi_select2:0
P3.0	-	Smartlo[1].io[0]	tcpwm.line[0]:0	scb[1].uart_rx:1	-	scb[1].i2c_scl:2	scb[1].spi_mosi:0
P3.1	-	Smartlo[1].io[1]	tcpwm.line_compl[0]:0	scb[1].uart_tx:1	-	scb[1].i2c_sda:2	scb[1].spi_miso:0
P3.2	-	Smartlo[1].io[2]	tcpwm.line[1]:0	scb[1].uart_cts:1	-	cpuss.swd_data	scb[1].spi_clk:0
P3.3	-	Smartlo[1].io[3]	tcpwm.line_compl[1]:0	scb[1].uart_rts:1	-	cpuss.swd_clk	scb[1].spi_select0:0
P3.4	-	Smartlo[1].io[4]	tcpwm.line[2]:0	-	tcpwm.tr_in[6]	-	scb[1].spi_select1:0
P3.5	-	Smartlo[1].io[5]	tcpwm.line_compl[2]:0	-	-	-	scb[1].spi_select2:0
P3.6	-	Smartlo[1].io[6]	tcpwm.line[3]:0	-	-	scb[4].spi_select3	scb[1].spi_select3:0
P3.7	-	Smartlo[1].io[7]	tcpwm.line_compl[3]:0	-	-	lpcomp.comp[1]:1	scb[2].spi_miso:1
P4.0	csd.vref_ext	-	-	scb[0].uart_rx:0	-	scb[0].i2c_scl:1	scb[0].spi_mosi:0
P4.1	csd.cshield	-	-	scb[0].uart_tx:0	-	scb[0].i2c_sda:1	scb[0].spi_miso:0
P4.2	csd.cmod	-	-	scb[0].uart_cts:0	-	lpcomp.comp[0]:1	scb[0].spi_clk:0
P4.3	csd.csh_tank	-	-	scb[0].uart_rts:0	-	lpcomp.comp[1]:2	scb[0].spi_select0:0
P4.4	-	-	-	scb[4].uart_rx	-	scb[4].spi_mosi	scb[0].spi_select1:2
P4.5	-	-	-	scb[4].uart_tx	-	scb[4].spi_miso	scb[0].spi_select2:2

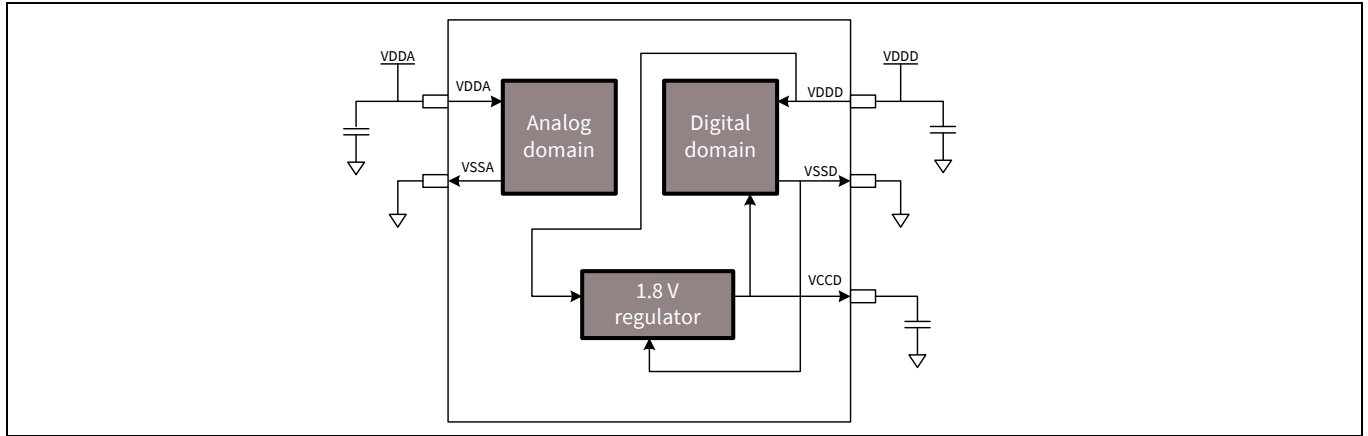


**Table 2**      **Alternate pin functions** *(continued)*

Port/pin	Analog	Smart I/O	ACT #0	ACT #1	ACT #3	DS #2	DS #3
P4.6	-	-	-	scb[4].uart_cts	-	scb[4].spi_clk	scb[0].spi_select3:2
P4.7	-	-	-	scb[4].uart_rts	-	scb[4].spi_select0	-
P5.6	-	-	tcpwm.line[7]:0	-	-	scb[4].spi_select1	-
P5.7	-	-	tcpwm.line_compl[7]:0	-	-	scb[4].spi_select2	-
P7.0	-	-	tcpwm.line[0]:2	scb[3].uart_rx:2	-	scb[3].i2c_scl:2	scb[3].spi_mosi:1
P7.1	-	-	tcpwm.line_compl[0]:2	scb[3].uart_tx:2	-	scb[3].i2c_sda:2	scb[3].spi_miso:1
P7.2	-	-	tcpwm.line[1]:2	scb[3].uart_cts:2	-	-	scb[3].spi_clk:1

## 4 Power

The following power system diagram shows the set of power supply pins as implemented for PSoC™ 4100S Plus 256 KB. The system has one regulator in Active mode for the digital circuitry. There is no analog regulator; the analog circuits run directly from the  $V_{DDA}$  input.



**Figure 5 Power supply connections**

There are two distinct modes of operation. In Mode 1, the supply voltage range is 1.8 V to 5.5 V (unregulated externally; internal regulator operational). In Mode 2, the supply range is 1.8 V  $\pm$ 5% (externally regulated; 1.71 to 1.89, internal regulator bypassed).

### 4.1 Mode 1: 1.8 V to 5.5 V external supply

In this mode, PSoC™ 4100S Plus 256 KB is powered by an external power supply that can be anywhere in the range of 1.8 to 5.5 V. This range is also designed for battery-powered operation. For example, the chip can be powered from a battery system that starts at 3.5 V and works down to 1.8 V. In this mode, the internal regulator of PSoC™ 4100S Plus 256 KB supplies the internal logic and its output is connected to the  $V_{CCD}$  pin. The  $V_{CCD}$  pin must be bypassed to ground via an external capacitor (0.1  $\mu$ F; X5R ceramic or better) and must not be connected to anything else.

### 4.2 Mode 2: 1.8 V $\pm$ 5% external supply

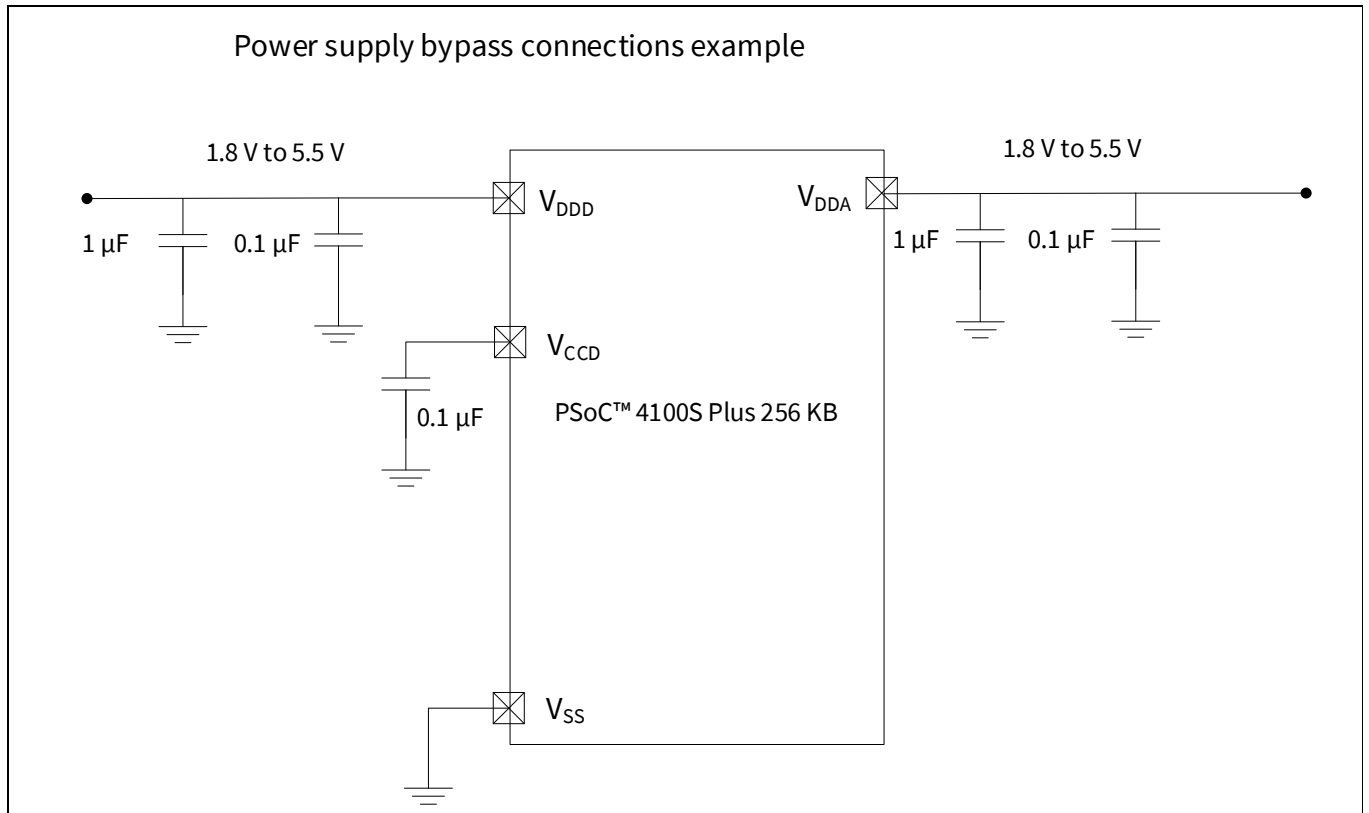
In this mode, PSoC™ 4100S Plus 256 KB is powered by an external power supply that must be within the range of 1.71 to 1.89 V; note that this range needs to include the power supply ripple too. In this mode, the VDD and VCCD pins are shorted together and bypassed. The internal regulator can be disabled in the firmware.

Bypass capacitors must be used from VDDD to ground. The typical practice for systems in this frequency range is to use a capacitor in the 1  $\mu$ F range, in parallel with a smaller capacitor (0.1  $\mu$ F, for example).

Note that these are simply rules of thumb and that, for critical applications, the PCB layout, lead inductance, and the bypass capacitor parasitic should be simulated to design and obtain optimal bypassing.

An example of a bypass scheme is shown in [Figure 6](#).





**Figure 6 External supply range from 1.8 V to 5.5 V with internal regulator active**

## 5 Electrical specifications

### 5.1 Absolute maximum ratings

**Table 3** Absolute maximum ratings<sup>[2]</sup>

Spec ID#	Parameter	Description	Min	Typ	Max	Unit	Details/conditions
SID1	V <sub>DDD_ABS</sub>	Digital supply relative to V <sub>SS</sub>	-0.5	-	6	V	-
SID2	V <sub>CCD_ABS</sub>	Direct digital core voltage input relative to V <sub>SS</sub>	-0.5	-	1.95	V	-
SID3	V <sub>GPIO_ABS</sub>	GPIO voltage	-0.5	-	V <sub>DD</sub> +0.5	V	-
SID4	I <sub>GPIO_ABS</sub>	Maximum current per GPIO	-25	-	25	mA	-
SID5	I <sub>GPIO_injection</sub>	GPIO injection current, Max for V <sub>IH</sub> > V <sub>DDD</sub> , and Min for V <sub>IL</sub> < V <sub>SS</sub>	-0.5	-	0.5	mA	Current injected per pin
BID44	ESD_HBM	Electrostatic discharge human body model	2200	-	-	V	-
BID45	ESD_CDM	Electrostatic discharge charged device model	500	-	-	V	-
BID46	LU	Pin current for latch-up	-140	-	140	mA	-

**Note**

2. Usage above the absolute maximum conditions listed in **Table 3** may cause permanent damage to the device. Exposure to absolute maximum conditions for extended periods of time may affect device reliability. The maximum storage temperature is 150°C in compliance with JEDEC Standard JESD22-A103, high temperature storage life. When used below absolute maximum conditions but above normal operating conditions, the device may not operate to specification.

### 5.2 Device level specifications

All specifications are valid for -40°C ≤ T<sub>A</sub> ≤ 105°C and T<sub>J</sub> ≤ 125°C, except where noted. Specifications are valid for 1.71 V to 5.5 V, except where noted.

**Table 4** DC specifications

Typical values measured at V<sub>DD</sub> = 3.3 V and 25°C

Spec ID#	Parameter	Description	Min	Typ	Max	Unit	Details/conditions
SID53	V <sub>DD</sub>	Power supply input voltage	1.8	-	5.5	V	Internally regulated supply
SID255	V <sub>DD</sub>	Power supply input voltage (V <sub>CCD</sub> = V <sub>DDD</sub> = V <sub>DDA</sub> )	1.71	-	1.89	V	Internally unregulated supply
SID54	V <sub>CCD</sub>	Output voltage (for core logic)	-	1.8	-	V	-
SID55	C <sub>EFC</sub>	External regulator voltage bypass	-	0.1	-	μF	X5R ceramic or better
SID56	C <sub>EXC</sub>	Power supply bypass capacitor	-	1	-	μF	X5R ceramic or better

**Active mode, V<sub>DD</sub> = 1.8 V to 5.5 V. Typical values measured at V<sub>DD</sub> = 3.3 V and 25°C**

SID10	I <sub>DD5</sub>	Execute from flash; CPU at 6 MHz	-	1.8	2.4	mA	-
SID16	I <sub>DD8</sub>	Execute from flash; CPU at 24 MHz	-	3.0	4.6	mA	-

Electrical specifications

**Table 4 DC specifications (continued)**

Typical values measured at  $V_{DD} = 3.3\text{ V}$  and  $25^\circ\text{C}$

Spec ID#	Parameter	Description	Min	Typ	Max	Unit	Details/ conditions
SID19	$I_{DD11}$	Execute from flash; CPU at 48 MHz	–	5.4	7.1	mA	–
<b>Sleep mode, <math>V_{DDD} = 1.8\text{ V to }5.5\text{ V}</math> (Regulator ON)</b>							
SID22	$I_{DD17}$	I <sup>2</sup> C wakeup WDT, and Comparators ON	–	1.1	2.1	mA	6 MHz
SID25	$I_{DD20}$	I <sup>2</sup> C wakeup, WDT, and Comparators ON	–	1.5	2.8	mA	12 MHz
<b>Sleep mode, <math>V_{DDD} = 1.71\text{ V to }1.89\text{ V}</math> (Regulator bypassed)</b>							
SID28	$I_{DD23}$	I <sup>2</sup> C wakeup, WDT, and Comparators ON	–	1.1	2.1	mA	6 MHz
SID28A	$I_{DD23A}$	I <sup>2</sup> C wakeup, WDT, and Comparators ON	–	1.5	2.8	mA	12 MHz
<b>Deep Sleep mode, <math>V_{DD} = 1.8\text{ V to }3.6\text{ V}</math> (Regulator ON)</b>							
SID30	$I_{DD25}$	I <sup>2</sup> C wakeup and WDT ON; $T = -40^\circ\text{C to }60^\circ\text{C}$	–	2.5	40	$\mu\text{A}$	$T = -40^\circ\text{C to }60^\circ\text{C}$
SID31	$I_{DD26}$	I <sup>2</sup> C wakeup and WDT ON	–	2.5	125	$\mu\text{A}$	Max is at 3.6 V and $85^\circ\text{C}$
<b>Deep Sleep mode, <math>V_{DD} = 3.6\text{ V to }5.5\text{ V}</math> (Regulator ON)</b>							
SID33	$I_{DD28}$	I <sup>2</sup> C wakeup and WDT ON; $T = -40^\circ\text{C to }60^\circ\text{C}$	–	2.5	40	$\mu\text{A}$	$T = -40^\circ\text{C to }60^\circ\text{C}$
SID34	$I_{DD29}$	I <sup>2</sup> C wakeup and WDT ON	–	2.5	125	$\mu\text{A}$	Max is at 5.5 V and $85^\circ\text{C}$
<b>Deep Sleep mode, <math>V_{DD} = V_{CCD} = 1.71\text{ V to }1.89\text{ V}</math> (Regulator bypassed)</b>							
SID36	$I_{DD31}$	I <sup>2</sup> C wakeup and WDT ON; $T = -40^\circ\text{C to }60^\circ\text{C}$	–	2.5	60	$\mu\text{A}$	$T = -40^\circ\text{C to }60^\circ\text{C}$
SID37	$I_{DD32}$	I <sup>2</sup> C wakeup and WDT ON	–	2.5	180	$\mu\text{A}$	Max is at 1.89 V and $85^\circ\text{C}$
<b>XRES current</b>							
SID307	$I_{DD\_XR}$	Supply current while XRES asserted	–	2	5	mA	–

**Table 5 AC specifications**

Spec ID#	Parameter	Description	Min	Typ	Max	Unit	Details/ conditions
SID48	F <sub>CPU</sub>	CPU frequency	DC	–	48	MHz	1.71 ≤ V <sub>DD</sub> ≤ 5.5
SID49 <sup>[3]</sup>	T <sub>SLEEP</sub>	Wakeup from Sleep mode	–	0	–	μs	–
SID50 <sup>[3]</sup>	T <sub>DEEPSLEEP</sub>	Wakeup from Deep Sleep mode	–	35	–	μs	–

**Note**

3. Guaranteed by characterization.

Electrical specifications

**5.2.1 GPIO**

**Table 6 GPIO DC specifications**

Spec ID#	Parameter	Description	Min	Typ	Max	Unit	Details/conditions
SID57	$V_{IH}^{[4]}$	Input voltage HIGH threshold	$0.7 \times V_{DDD}$	-	-	V	CMOS Input
SID58	$V_{IL}$	Input voltage LOW threshold	-	-	$0.3 \times V_{DDD}$	V	CMOS Input
SID241	$V_{IH}^{[4]}$	LVTTL input, $V_{DDD} < 2.7\text{ V}$	$0.7 \times V_{DDD}$	-	-	V	-
SID242	$V_{IL}$	LVTTL input, $V_{DDD} < 2.7\text{ V}$	-	-	$0.3 \times V_{DDD}$	V	-
SID243	$V_{IH}^{[4]}$	LVTTL input, $V_{DDD} \geq 2.7\text{ V}$	2.0	-	-	V	-
SID244	$V_{IL}$	LVTTL input, $V_{DDD} \geq 2.7\text{ V}$	-	-	0.8	V	-
SID59	$V_{OH}$	Output voltage HIGH level	$V_{DDD} - 0.6$	-	-	V	$I_{OH} = 4\text{ mA}$ at 3 V $V_{DDD}$
SID60	$V_{OH}$	Output voltage HIGH level	$V_{DDD} - 0.5$	-	-	V	$I_{OH} = 1\text{ mA}$ at 1.8 V $V_{DDD}$
SID61	$V_{OL}$	Output voltage LOW level	-	-	0.6	V	$I_{OL} = 4\text{ mA}$ at 1.8 V $V_{DDD}$
SID62	$V_{OL}$	Output voltage LOW level	-	-	0.6	V	$I_{OL} = 10\text{ mA}$ at 3 V $V_{DDD}$
SID62A	$V_{OL}$	Output voltage LOW level	-	-	0.4	V	$I_{OL} = 3\text{ mA}$ at 3 V $V_{DDD}$
SID63	$R_{PULLUP}$	Pull-up resistor	3.5	5.6	8.5	k $\Omega$	-
SID64	$R_{PULLDOWN}$	Pull-down resistor	3.5	5.6	8.5	k $\Omega$	-
SID65	$I_{IL}$	Input leakage current (absolute value)	-	-	2	nA	25°C, $V_{DDD} = 3.0\text{ V}$
SID66	$C_{IN}$	Input capacitance	-	-	7	pF	-
SID67 <sup>[5]</sup>	$V_{HYSTTL}$	Input hysteresis LVTTL	25	40	-	mV	$V_{DDD} \geq 2.7\text{ V}$
SID68 <sup>[5]</sup>	$V_{HYSCMOS}$	Input hysteresis CMOS	$0.05 \times V_{DDD}$	-	-	mV	$V_{DD} < 4.5\text{ V}$
SID68A <sup>[5]</sup>	$V_{HYSCMOS5V5}$	Input hysteresis CMOS	200	-	-	mV	$V_{DD} > 4.5\text{ V}$
SID69 <sup>[5]</sup>	$I_{DIODE}$	Current through protection diode to $V_{DD}/V_{SS}$	-	-	100	$\mu\text{A}$	-
SID69A <sup>[5]</sup>	$I_{TOT\_GPIO}$	Maximum total source or sink chip current	-	-	200	mA	-

**Notes**

- 4.  $V_{IH}$  must not exceed  $V_{DDD} + 0.2\text{ V}$ .
- 5. Guaranteed by characterization.

Electrical specifications

**Table 7 GPIO AC specifications**  
(Guaranteed by characterization)

Spec ID#	Parameter	Description	Min	Typ	Max	Unit	Details/conditions
SID70	T <sub>RISEF</sub>	Rise time in Fast strong mode	2	–	12	ns	3.3 V V <sub>DDD</sub> , Clload = 25 pF
SID71	T <sub>FALLF</sub>	Fall time in Fast strong mode	2	–	12	ns	3.3 V V <sub>DDD</sub> , Clload = 25 pF
SID72	T <sub>RISES</sub>	Rise time in Slow strong mode	10	–	60	ns	3.3 V V <sub>DDD</sub> , Clload = 25 pF
SID73	T <sub>FALLS</sub>	Fall time in Slow strong mode	10	–	60	ns	3.3 V V <sub>DDD</sub> , Clload = 25 pF
SID74	F <sub>GPIOUT1</sub>	GPIO F <sub>OUT</sub> ; 3.3 V ≤ V <sub>DDD</sub> ≤ 5.5 V Fast strong mode	–	–	33	MHz	90/10%, 25 pF load, 60/40 duty cycle
SID75	F <sub>GPIOUT2</sub>	GPIO F <sub>OUT</sub> ; 1.71 V ≤ V <sub>DDD</sub> ≤ 3.3 V Fast strong mode	–	–	16.7	MHz	90/10%, 25 pF load, 60/40 duty cycle
SID76	F <sub>GPIOUT3</sub>	GPIO F <sub>OUT</sub> ; 3.3 V ≤ V <sub>DDD</sub> ≤ 5.5 V Slow strong mode	–	–	7	MHz	90/10%, 25 pF load, 60/40 duty cycle
SID245	F <sub>GPIOUT4</sub>	GPIO F <sub>OUT</sub> ; 1.71 V ≤ V <sub>DDD</sub> ≤ 3.3 V Slow strong mode.	–	–	3.5	MHz	90/10%, 25 pF load, 60/40 duty cycle
SID246	F <sub>GPIOIN</sub>	GPIO input operating frequency; 1.71 V ≤ V <sub>DDD</sub> ≤ 5.5 V	–	–	48	MHz	90/10% V <sub>I0</sub>

## 5.2.2 XRES

**Table 8 XRES DC specifications**

Spec ID#	Parameter	Description	Min	Typ	Max	Unit	Details/conditions
SID77	V <sub>IH</sub>	Input voltage HIGH threshold	0.7 × V <sub>DDD</sub>	–	–	V	CMOS Input
SID78	V <sub>IL</sub>	Input voltage LOW threshold	–	–	0.3 × V <sub>DDD</sub>	V	
SID79	R <sub>PULLUP</sub>	Pull-up resistor	–	60	–	kΩ	–
SID80	C <sub>IN</sub>	Input capacitance	–	–	7	pF	–
SID81 <sup>[6]</sup>	V <sub>HYSXRES</sub>	Input voltage hysteresis	–	100	–	mV	Typical hysteresis is 200 mV for V <sub>DD</sub> > 4.5 V
SID82	I <sub>DIODE</sub>	Current through protection diode to V <sub>DD</sub> /V <sub>SS</sub>	–	–	100	μA	–

**Table 9 XRES AC specifications**

Spec ID#	Parameter	Description	Min	Typ	Max	Unit	Details/conditions
SID83 <sup>[6]</sup>	T <sub>RESETWIDTH</sub>	Reset pulse width	1	–	–	μs	–
BID194 <sup>[6]</sup>	T <sub>RESETWAKE</sub>	Wake-up time from reset release	–	–	2.7	ms	–

**Note**

6. Guaranteed by characterization.



## 5.3 Analog peripherals

### 5.3.1 CTBm Opamp

**Table 10 CTBm Opamp specifications**

Spec ID#	Parameter	Description	Min	Typ	Max	Unit	Details/conditions
	$I_{DD}$	Opamp block current, External load					
SID269	$I_{DD\_HI}$	power = hi	-	1100	1900	$\mu A$	-
SID270	$I_{DD\_MED}$	power = med	-	550	1020	$\mu A$	-
SID271	$I_{DD\_LOW}$	power = lo	-	150	370	$\mu A$	-
	$G_{BW}$	Load = 50 pF, 0.1 mA $V_{DDA} = 2.7 V$					
SID272	$G_{BW\_HI}$	power = hi	6	-	-	MHz	Input and output are 0.2 V to $V_{DDA}-0.2 V$
SID273	$G_{BW\_MED}$	power = med	3	-	-	MHz	Input and output are 0.2 V to $V_{DDA}-0.2 V$
SID274	$G_{BW\_LO}$	power = lo	-	1	-	MHz	Input and output are 0.2 V to $V_{DDA}-0.2 V$
	$I_{OUT\_MAX}$	$V_{DDA} = 2.7 V$ , 500 mV from rail					
SID275	$I_{OUT\_MAX\_HI}$	power = hi	10	-	-	mA	Output is 0.5 V to $V_{DDA}-0.5 V$
SID276	$I_{OUT\_MAX\_MID}$	power = mid	10	-	-	mA	Output is 0.5 V to $V_{DDA}-0.5 V$
SID277	$I_{OUT\_MAX\_LO}$	power = lo	-	5	-	mA	Output is 0.5 V to $V_{DDA}-0.5 V$
	$I_{OUT}$	$V_{DDA} = 1.71 V$ , 500 mV from rail					
SID278	$I_{OUT\_MAX\_HI}$	power = hi	4	-	-	mA	Output is 0.5 V to $V_{DDA}-0.5 V$
SID279	$I_{OUT\_MAX\_MID}$	power = mid	4	-	-	mA	Output is 0.5 V to $V_{DDA}-0.5 V$
SID280	$I_{OUT\_MAX\_LO}$	power = lo	-	2	-	mA	Output is 0.5 V to $V_{DDA}-0.5 V$
	$I_{DD\_Int}$	Opamp block current Internal Load					
SID269_I	$I_{DD\_HI\_Int}$	power = hi	-	1500	1700	$\mu A$	-
SID270_I	$I_{DD\_MED\_Int}$	power = med	-	700	980	$\mu A$	-
SID271_I	$I_{DD\_LOW\_Int}$	power = lo	-	-	405	$\mu A$	-
	$G_{BW}$	$V_{DDA} = 2.7 V$	-	-	-	-	-
SID272_I	$G_{BW\_HI\_Int}$	power=hi	8	-	-	MHz	Output is 0.25 V to $V_{DDA}-0.25 V$

Electrical specifications

**Table 10** CTBm Opamp specifications (continued)

Spec ID#	Parameter	Description	Min	Typ	Max	Unit	Details/conditions	
		General Opamp specs for both internal and external modes	-					
SID281	$V_{IN}$	Charge-pump on, $V_{DDA} = 2.7\text{ V}$	-0.05	-	$V_{DDA} - 0.2$	V	-	
SID282	$V_{CM}$	Charge-pump on, $V_{DDA} = 2.7\text{ V}$	-0.05	-	$V_{DDA} - 0.2$	V	-	
	$V_{OUT}$	$V_{DDA} = 2.7\text{ V}$	-					
SID283	$V_{OUT\_1}$	power = hi, Iload=10 mA	0.5	-	$V_{DDA} - 0.5$	V	-	
SID284	$V_{OUT\_2}$	power = hi, Iload=1 mA	0.2	-	$V_{DDA} - 0.2$	V	-	
SID285	$V_{OUT\_3}$	power = med, Iload=1 mA	0.2	-	$V_{DDA} - 0.2$	V	-	
SID286	$V_{OUT\_4}$	power = lo, Iload=0.1 mA	0.2	-	$V_{DDA} - 0.2$	V	-	
SID288	$V_{OS\_TR}$	Offset voltage, trimmed	-1.0	$\pm 0.5$	1.0	mV	High mode, input 0 V to $V_{DDA} - 0.2\text{ V}$	
SID288A	$V_{OS\_TR}$	Offset voltage, trimmed	-	$\pm 1$	-	mV	Medium mode, input 0 V to $V_{DDA} - 0.2\text{ V}$	
SID288B	$V_{OS\_TR}$	Offset voltage, trimmed	-	$\pm 2$	-	mV	Low mode, input 0 V to $V_{DDA} - 0.2\text{ V}$	
SID290	$V_{OS\_DR\_TR}$	Offset voltage drift, trimmed	-10	$\pm 3$	10	$\mu\text{V}/^\circ\text{C}$	High mode	
SID290A	$V_{OS\_DR\_TR}$	Offset voltage drift, trimmed	-	$\pm 10$	-	$\mu\text{V}/^\circ\text{C}$	Medium mode	
SID290B	$V_{OS\_DR\_TR}$	Offset voltage drift, trimmed	-	$\pm 10$	-	$\mu\text{V}/^\circ\text{C}$	Low mode	
SID291	CMRR	DC	70	80	-	dB	Input is 0 V to $V_{DDA} - 0.2\text{ V}$ , Output is 0.2 V to $V_{DDA} - 0.2\text{ V}$	
SID292	PSRR	At 1 kHz, 10-mV ripple	70	85	-	dB	$V_{DD} = 3.6\text{ V}$ , High-power mode, input is 0.2 V to $V_{DDA} - 0.2\text{ V}$	

Electrical specifications

**Table 10** CTBm Opamp specifications (continued)

Spec ID#	Parameter	Description	Min	Typ	Max	Unit	Details/conditions
	<b>Noise</b>						
SID294	VN2	Input-referred, 1 kHz, power = hi	–	72	–	nV/rtHz	Input and output are at 0.2 V to $V_{DDA}-0.2$ V
SID295	VN3	Input-referred, 10 kHz, power = hi	–	28	–	nV/rtHz	Input and output are at 0.2 V to $V_{DDA}-0.2$ V
SID296	VN4	Input-referred, 100 kHz, power = hi	–	15	–	nV/rtHz	Input and output are at 0.2 V to $V_{DDA}-0.2$ V
SID297	$C_{LOAD}$	Stable up to max. load. Performance specs at 50 pF.	–	–	125	pF	–
SID298	SLEW_RATE	Clod = 50 pF, power = High, $V_{DDA} = 2.7$ V	4	–	–	V/ $\mu$ s	–
SID299	T_OP_WAKE	From disable to enable, no external RC dominating	–	–	25	$\mu$ s	–
SID299A	OL_GAIN	Open Loop Gain	–	90	–	dB	–
	COMP_MODE	Comparator mode; 50 mV drive, $T_{rise}=T_{fall}$ (approx.)	–				
SID300	TPD1	Response time; power = hi	–	150	–	ns	Input is 0.2 V to $V_{DDA}-0.2$ V
SID301	TPD2	Response time; power = med	–	500	–	ns	Input is 0.2 V to $V_{DDA}-0.2$ V
SID302	TPD3	Response time; power = lo	–	2500	–	ns	Input is 0.2 V to $V_{DDA}-0.2$ V
SID303	VHYST_OP	Hysteresis	–	10	–	mV	–
SID304	WUP_CTB	Wake-up time from Enabled to Usable	–	–	25	$\mu$ s	–
	Deep Sleep mode	Mode 2 is lowest current range. Mode 1 has higher GBW.	–				
SID_DS_1	$I_{DD\_HI\_M1}$	Mode 1, High current	–	1400	–	$\mu$ A	25°C
SID_DS_2	$I_{DD\_MED\_M1}$	Mode 1, Medium current	–	700	–	$\mu$ A	25°C
SID_DS_3	$I_{DD\_LOW\_M1}$	Mode 1, Low current	–	200	–	$\mu$ A	25°C
SID_DS_4	$I_{DD\_HI\_M2}$	Mode 2, High current	–	120	–	$\mu$ A	25°C
SID_DS_5	$I_{DD\_MED\_M2}$	Mode 2, Medium current	–	60	–	$\mu$ A	25°C
SID_DS_6	$I_{DD\_LOW\_M2}$	Mode 2, Low current	–	15	–	$\mu$ A	25°C

Electrical specifications

**Table 10** CTBm Opamp specifications (continued)

Spec ID#	Parameter	Description	Min	Typ	Max	Unit	Details/conditions
SID_DS_7	G <sub>BW_HI_M1</sub>	Mode 1, High current	–	4	–	MHz	20 pF load, no DC load 0.2 V to V <sub>DDA</sub> -0.2 V
SID_DS_8	G <sub>BW_MED_M1</sub>	Mode 1, Medium current	–	2	–	MHz	20 pF load, no DC load 0.2 V to V <sub>DDA</sub> -0.2 V
SID_DS_9	G <sub>BW_LOW_M1</sub>	Mode 1, Low current	–	0.5	–	MHz	20 pF load, no DC load 0.2 V to V <sub>DDA</sub> -0.2 V
SID_DS_10	G <sub>BW_HI_M2</sub>	Mode 2, High current	–	0.5	–	MHz	20 pF load, no DC load 0.2 V to V <sub>DDA</sub> -0.2 V
SID_DS_11	G <sub>BW_MED_M2</sub>	Mode 2, Medium current	–	0.2	–	MHz	20 pF load, no DC load 0.2 V to V <sub>DDA</sub> -0.2 V
SID_DS_12	G <sub>BW_LOW_M2</sub>	Mode 2, Low current	–	0.1	–	MHz	20 pF load, no DC load 0.2 V to V <sub>DDA</sub> -0.2 V
SID_DS_13	V <sub>OS_HI_M1</sub>	Mode 1, High current	–	5	–	mV	With trim 25 °C, 0.2 V to V <sub>DDA</sub> -0.2 V
SID_DS_14	V <sub>OS_MED_M1</sub>	Mode 1, Medium current	–	5	–	mV	With trim 25 °C, 0.2 V to V <sub>DDA</sub> -0.2 V
SID_DS_15	V <sub>OS_LOW_M1</sub>	Mode 1, Low current	–	5	–	mV	With trim 25 °C, 0.2 V to V <sub>DDA</sub> -0.2 V
SID_DS_16	V <sub>OS_HI_M2</sub>	Mode 2, High current	–	5	–	mV	With trim 25 °C, 0.2V to V <sub>DDA</sub> -0.2 V
SID_DS_17	V <sub>OS_MED_M2</sub>	Mode 2, Medium current	–	5	–	mV	With trim 25 °C, 0.2 V to V <sub>DDA</sub> -0.2 V
SID_DS_18	V <sub>OS_LOW_M2</sub>	Mode 2, Low current	–	5	–	mV	With trim 25 °C, 0.2 V to V <sub>DDA</sub> -0.2 V
SID_DS_19	I <sub>OUT_HI_M1</sub>	Mode 1, High current	–	10	–	mA	Output is 0.5 V to V <sub>DDA</sub> -0.5 V
SID_DS_20	I <sub>OUT_MED_M1</sub>	Mode 1, Medium current	–	10	–	mA	Output is 0.5 V to V <sub>DDA</sub> -0.5 V
SID_DS_21	I <sub>OUT_LOW_M1</sub>	Mode 1, Low current	–	4	–	mA	Output is 0.5 V to V <sub>DDA</sub> -0.5 V
SID_DS_22	I <sub>OUT_HI_M2</sub>	Mode 2, High current	–	1	–	mA	–

Electrical specifications

**Table 10 CTBm Opamp specifications (continued)**

Spec ID#	Parameter	Description	Min	Typ	Max	Unit	Details/conditions
SID_DS_23	I <sub>OUT_MED_M2</sub>	Mode 2, Medium current	–	1	–	mA	–
SID_DS_24	I <sub>OUT_LOW_M2</sub>	Mode 2, Low current	–	0.5	–	mA	–

### 5.3.2 Comparator

**Table 11 Comparator DC specifications**

Spec ID#	Parameter	Description	Min	Typ	Max	Unit	Details/conditions
SID84	V <sub>OFFSET1</sub>	Input offset voltage, Factory trim	–	–	±10	mV	–
SID85	V <sub>OFFSET2</sub>	Input offset voltage, Custom trim	–	–	±4	mV	–
SID86	V <sub>HYST</sub>	Hysteresis when enabled	–	10	35	mV	–
SID87	V <sub>ICM1</sub>	Input common mode voltage in Normal mode	0	–	V <sub>DDD</sub> -0.1	V	Modes 1 and 2
SID247	V <sub>ICM2</sub>	Input common mode voltage in Low-power mode	0	–	V <sub>DDD</sub>	V	–
SID247A	V <sub>ICM3</sub>	Input common mode voltage in Ultra low power mode	0	–	V <sub>DDD</sub> -1.15	V	V <sub>DDD</sub> ≥ 2.2 V at –40°C
SID88	C <sub>MRR</sub>	Common mode rejection ratio	50	–	–	dB	V <sub>DDD</sub> ≥ 2.7 V
SID88A	C <sub>MRR</sub>	Common mode rejection ratio	42	–	–	dB	V <sub>DDD</sub> ≤ 2.7 V
SID89	I <sub>CMP1</sub>	Block current, normal mode	–	–	400	μA	–
SID248	I <sub>CMP2</sub>	Block current, Low-power mode	–	–	100	μA	–
SID259	I <sub>CMP3</sub>	Block current in Ultra low-power mode	–	–	6	μA	V <sub>DDD</sub> ≥ 2.2 V at –40°C
SID90	Z <sub>CMP</sub>	DC Input impedance of comparator	35	–	–	MΩ	–

**Table 12 Comparator AC specifications**

Spec ID#	Parameter	Description	Min	Typ	Max	Unit	Details/conditions
SID91	TRESP1	Response time, Normal mode, 50 mV overdrive	–	38	110	ns	–
SID258	TRESP2	Response time, Low-power mode, 50 mV overdrive	–	70	200	ns	–
SID92	TRESP3	Response time, Ultra low-power mode, 200 mV overdrive	–	2.3	15	μs	V <sub>DDD</sub> ≥ 2.2 V at –40°C

**Note**

7. Guaranteed by characterization.

Electrical specifications

### 5.3.3 Temperature sensor

**Table 13 Temperature sensor specifications**

Spec ID#	Parameter	Description	Min	Typ	Max	Unit	Details/ conditions
SID93	TSENSACC	Temperature sensor accuracy	-5	±1	5	°C	-40 to +85°C

### 5.3.4 SAR ADC

**Table 14 SAR ADC specifications**

Spec ID#	Parameter	Description	Min	Typ	Max	Unit	Details/ conditions
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#### SAR ADC DC specifications

SID94	A_RES	Resolution	-	-	12	bits	-
SID95	A_CHNLS_S	Number of channels - single ended	-	-	16		-
SID96	A-CHNKS_D	Number of channels - differential	-	-	4		Diff inputs use neighboring I/O
SID97	A-MONO	Monotonicity	Yes				-
SID98	A_GAINERR	Gain error	-	-	±0.125	%	With external reference
SID99	A_OFFSET	Input offset voltage	-	-	±2.3	mV	Measured with 1-V reference
SID100	A_ISAR	Current consumption	-	-	1	mA	-
SID101	A_VINS	Input voltage range - single ended	V <sub>SS</sub>	-	V <sub>DDA</sub>	V	-
SID102	A_VIND	Input voltage range - differential	V <sub>SS</sub>	-	V <sub>DDA</sub>	V	-
SID103	A_INRES	Input resistance	-	-	2.2	KΩ	-
SID104	A_INCAP	Input capacitance	-	-	10	pF	-
SID260	VREFSAR	Trimmed internal reference to SAR	1.188	1.2	1.212	V	-

#### SAR ADC AC specifications

SID106	A_PSRR	Power supply rejection ratio	70	-	-	dB	-
SID107	A_CMRR	Common mode rejection ratio	66	-	-	dB	Measured at 1 V
SID108	A_SAMP	Sample rate	-	-	1	Msps	-
SID109	A_SNR	Signal-to-noise and distortion ratio (SINAD)	64	-	-	dB	F <sub>IN</sub> = 10 kHz
SID110	A_BW	Input bandwidth without aliasing	-	-	A_samp/2	kHz	-
SID111	A_INL	Integral non linearity	-3	-	3	LSB	-
SID112	A_DNL	Differential non linearity	-1	-	3	LSB	-
SID113	A_THD	Total harmonic distortion	-	-	-62	dB	F <sub>IN</sub> = 10 kHz
SID261	FSARINTREF	SAR operating speed without external reference bypass	-	-	100	ksps	12-bit resolution



### 5.3.5 CSD and IDAC

**Table 15 CSD and IDAC specifications**

Spec ID#	Parameter	Description	Min	Typ	Max	Unit	Details/conditions
SYS.PER#3	VDD_RIPPLE	Max allowed ripple on power supply, DC to 10 MHz	-	-	±50	mV	$V_{DD} > 2\text{ V}$ (with ripple), $25^\circ\text{C } T_A$ , Sensitivity = 0.1 pF
SYS.PER#16	VDD_RIP- PLE_1.8	Max allowed ripple on power supply, DC to 10 MHz	-	-	±25	mV	$V_{DD} > 1.75\text{ V}$ (with ripple), $25^\circ\text{C } T_A$ , Parasitic Capacitance ( $C_p$ ) < 20 pF, Sensitivity $\geq 0.4\text{ pF}$
SID.CSD.BLK	ICSD	Maximum block current	-	-	4000	µA	Maximum block current for both IDACs in dynamic (switching) mode including comparators, buffer, and reference generator
SID.CSD#15	$V_{REF}$	Voltage reference for CSD and comparator	0.6	1.2	$V_{DDA} - 0.6$	V	$V_{DDA} - 0.6$ or 4.4, whichever is lower
SID.CSD#16	IDAC1IDD	IDAC1 (7-bits) block current	-	-	1750	µA	-
SID.CSD#17	IDAC2IDD	IDAC2 (7-bits) block current	-	-	1750	µA	-
SID308	VCSD	Voltage range of operation	1.71	-	5.5	V	1.8 V ±5% or 1.8 V to 5.5 V
SID308A	VCOMPIDAC	Voltage compliance range of IDAC	0.6	-	$V_{DDA} - 0.6$	V	$V_{DDA} - 0.6$ or 4.4, whichever is lower
SID309	IDAC1DNL	IDAC1DNL	-1	-	1	LSB	-
SID310	IDAC1INL	IDAC1INL	-2	-	2	LSB	INL is ±5.5 LSB for $V_{DDA} < 2\text{ V}$
SID311	IDAC2DNL	IDAC2DNL	-1	-	1	LSB	-
SID312	IDAC2INL	IDAC2INL	-2	-	2	LSB	INL is ±5.5 LSB for $V_{DDA} < 2\text{ V}$
SID313	SNR	Ratio of counts of finger to noise. Guaranteed by characterization	5	-	-	Ratio	Capacitance range of 5 to 35 pF, 0.1 pF sensitivity. All use cases. $V_{DDA} > 2\text{ V}$ .
SID314	IDAC1CRT1	Output current of IDAC1 (7 bits) in low range	4.2	-	5.4	µA	LSB = 37.5 nA typ
SID314A	IDAC1CRT2	Output current of IDAC1 (7 bits) in medium range	34	-	41	µA	LSB = 300 nA typ
SID314B	IDAC1CRT3	Output current of IDAC1 (7 bits) in high range	275	-	330	µA	LSB = 2.4 µA typ
SID314C	IDAC1CRT12	Output current of IDAC1 (7 bits) in low range, 2X mode	8	-	10.5	µA	LSB = 75 nA typ
SID314D	IDAC1CRT22	Output current of IDAC1 (7 bits) in medium range, 2X mode	69	-	82	µA	LSB = 600 nA typ

Electrical specifications

**Table 15** CSD and IDAC specifications (continued)

Spec ID#	Parameter	Description	Min	Typ	Max	Unit	Details/conditions
SID314E	IDAC1CRT32	Output current of IDAC1 (7 bits) in high range, 2X mode	540	-	660	μA	LSB = 4.8 μA typ
SID315	IDAC2CRT1	Output current of IDAC2 (7 bits) in low range	4.2	-	5.4	μA	LSB = 37.5 nA typ
SID315A	IDAC2CRT2	Output current of IDAC2 (7 bits) in medium range	34	-	41	μA	LSB = 300 nA typ
SID315B	IDAC2CRT3	Output current of IDAC2 (7 bits) in high range	275	-	330	μA	LSB = 2.4 μA typ
SID315C	IDAC2CRT12	Output current of IDAC2 (7 bits) in low range, 2X mode	8	-	10.5	μA	LSB = 75 nA typ
SID315D	IDAC2CRT22	Output current of IDAC2 (7 bits) in medium range, 2X mode	69	-	82	μA	LSB = 600 nA typ
SID315E	IDAC2CRT32	Output current of IDAC2 (7 bits) in high range, 2X mode	540	-	660	μA	LSB = 4.8 μA typ
SID315F	IDAC3CRT13	Output current of IDAC in 8-bit mode in low range	8	-	10.5	μA	LSB = 37.5 nA typ
SID315G	IDAC3CRT23	Output current of IDAC in 8-bit mode in medium range	69	-	82	μA	LSB = 300 nA typ
SID315H	IDAC3CRT33	Output current of IDAC in 8-bit mode in high range	540	-	660	μA	LSB = 2.4 μA typ
SID320	IDACOFFSET	All zeroes input	-	-	1	LSB	Polarity set by source or sink. Offset is 2 LSBs for 37.5 nA/LSB mode
SID321	IDACGAIN	Full-scale error less offset	-	-	±10	%	-
SID322	IDACMIS-MATCH1	Mismatch between IDAC1 and IDAC2 in Low range	-	-	9.2	LSB	LSB = 37.5 nA typ
SID322A	IDACMIS-MATCH2	Mismatch between IDAC1 and IDAC2 in Medium range	-	-	5.6	LSB	LSB = 300 nA typ
SID322B	IDACMIS-MATCH3	Mismatch between IDAC1 and IDAC2 in High range	-	-	6.8	LSB	LSB = 2.4 μA typ
SID323	IDACSET8	Settling time to 0.5 LSB for 8-bit IDAC	-	-	5	μs	Full-scale transition. No external load.
SID324	IDACSET7	Settling time to 0.5 LSB for 7-bit IDAC	-	-	5	μs	Full-scale transition. No external load.
SID325	CMOD	External modulator capacitor	-	2.2	-	nF	5 V rating, X7R or NP0 cap

### 5.3.6 10-bit CAPSENSE™ ADC

**Table 16 10-bit CAPSENSE™ ADC specifications**

Spec ID#	Parameter	Description	Min	Typ	Max	Unit	Details/conditions
SIDA94	A_RES	Resolution	–	–	10	bits	Auto-zeroing is required every milli-second
SIDA95	A_CHNLS_S	Number of channels - single ended	–	–	16		Defined by AMUX Bus
SIDA97	A-MONO	Monotonicity	Yes				–
SIDA98	A_GAINERR	Gain error	–	–	±3	%	In $V_{REF}$ (2.4 V) mode with $V_{DDA}$ bypass capacitance of 10 $\mu$ F
SIDA99	A_OFFSET	Input offset voltage	–	–	±18	mV	In $V_{REF}$ (2.4 V) mode with $V_{DDA}$ bypass capacitance of 10 $\mu$ F
SIDA100	A_ISAR	Current consumption	–	–	0.25	mA	–
SIDA101	A_VINS	Input voltage range - single ended	$V_{SSA}$	–	$V_{DDA}$	V	–
SIDA103	A_INRES	Input resistance	–	2.2	–	K $\Omega$	–
SIDA104	A_INCAP	Input capacitance	–	20	–	pF	–
SIDA106	A_PSR	Power supply rejection ratio	–	60	–	dB	In $V_{REF}$ (2.4 V) mode with $V_{DDA}$ bypass capacitance of 10 $\mu$ F
SIDA107	A_TACQ	Sample acquisition time	–	1	–	$\mu$ s	–
SIDA108	A_CONV8	Conversion time for 8-bit resolution at conversion rate = $F_{hclk}/(2^{(N+2)})$ . Clock frequency = 48 MHz.	–	–	21.3	$\mu$ s	Does not include acquisition time. Equivalent to 44.8 ksp/s including acquisition time.
SIDA108A	A_CONV10	Conversion time for 10-bit resolution at conversion rate = $F_{hclk}/(2^{(N+2)})$ . Clock frequency = 48 MHz.	–	–	85.3	$\mu$ s	Does not include acquisition time. Equivalent to 11.6 ksp/s including acquisition time.
SIDA109	A_SND	Signal-to-noise and distortion ratio (SINAD)	–	59	–	dB	With 10 Hz input sine wave, internal reference, $V_{REF}$ (2.4 V) mode
SIDA110	A_BW	Input bandwidth without aliasing	–	–	22.4	KHz	8-bit resolution
SIDA111	A_INL	Integral non linearity. 1 ksp/s	–	–	2	LSB	$V_{REF} = 2.4$ V or greater
SIDA112	A_DNL	Differential non linearity. 1 ksp/s	–	–	1	LSB	–

Electrical specifications

## 5.4 Digital peripherals

### 5.4.1 Timer, Counter, Pulse-width modulator (TCPWM)

**Table 17 TCPWM specifications**

Spec ID#	Parameter	Description	Min	Typ	Max	Unit	Details/conditions
SID.TCPWM.1	ITCPWM1	Block current consumption at 3 MHz	–	–	45	μA	All modes (TCPWM)
SID.TCPWM.2	ITCPWM2	Block current consumption at 12 MHz	–	–	155	μA	All modes (TCPWM)
SID.TCPWM.2A	ITCPWM3	Block current consumption at 48 MHz	–	–	650	μA	All modes (TCPWM)
SID.TCPWM.3	TCPWM <sub>FREQ</sub>	Operating frequency	–	–	F <sub>c</sub>	MHz	F <sub>c</sub> max = CLK_SYS Maximum = 48 MHz
SID.TCPWM.4	TPWM <sub>ENEXT</sub>	Input trigger pulse width	2/F <sub>c</sub>	–	–	ns	For all trigger events <sup>[8]</sup>
SID.TCPWM.5	TPWM <sub>EXT</sub>	Output trigger pulse widths	2/F <sub>c</sub>	–	–	ns	Minimum possible width of overflow, underflow, and CC (Counter equals compare value) outputs
SID.TCPWM.5A	TC <sub>RES</sub>	Resolution of counter	1/F <sub>c</sub>	–	–	ns	Minimum time between successive counts
SID.TCPWM.5B	PWM <sub>RES</sub>	PWM resolution	1/F <sub>c</sub>	–	–	ns	Minimum pulse width of PWM output
SID.TCPWM.5C	Q <sub>RES</sub>	Quadrature inputs resolution	1/F <sub>c</sub>	–	–	ns	Minimum pulse width between quadrature phase inputs

### 5.4.2 I<sup>2</sup>C

**Table 18 Fixed I<sup>2</sup>C DC specifications<sup>[8]</sup>**

Spec ID#	Parameter	Description	Min	Typ	Max	Unit	Details/conditions
SID149	I <sub>I2C1</sub>	Block current consumption at 100 kHz	–	–	50	μA	–
SID150	I <sub>I2C2</sub>	Block current consumption at 400 kHz	–	–	135	μA	–
SID151	I <sub>I2C3</sub>	Block current consumption at 1 Mbps	–	–	310	μA	–
SID152	I <sub>I2C4</sub>	Block current in Deep Sleep mode	–	1	–	μA	–

**Table 19 Fixed I<sup>2</sup>C AC specifications<sup>[8]</sup>**

Spec ID#	Parameter	Description	Min	Typ	Max	Unit	Details/conditions
SID153	F <sub>I2C1</sub>	Bit Rate	–	–	1	Msp/s	–

**Note**

8. Guaranteed by characterization.

### 5.4.3 SPI

**Table 20 SPI DC specifications<sup>[9]</sup>**

Spec ID#	Parameter	Description	Min	Typ	Max	Unit	Details/conditions
SID163	ISPI1	Block current consumption at 1 Mbps	–	–	360	μA	–
SID164	ISPI2	Block current consumption at 4 Mbps	–	–	560	μA	–
SID165	ISPI3	Block current consumption at 8 Mbps	–	–	600	μA	–

**Table 21 SPI AC specifications<sup>[9]</sup>**

Spec ID#	Parameter	Description	Min	Typ	Max	Unit	Details/conditions
SID166	FSPI	SPI operating frequency (Master; 6X oversampling)	–	–	8	MHz	–

#### Fixed SPI Master mode AC specifications

SID167	TDMO	MOSI valid after SClk driving edge	–	–	15	ns	–
SID168	TDSI	MISO valid before SClk capturing edge	20	–	–	ns	Full clock, late MISO sampling
SID169	THMO	Previous MOSI data hold time	0	–	–	ns	Referred to slave capturing edge

#### Fixed SPI Slave mode AC specifications

SID170	TDMI	MOSI valid before SClk capturing edge	40	–	–	ns	–
SID171	TDSO	MISO valid after SClk driving edge	–	–	42 + 3*T <sub>cpu</sub>	ns	T <sub>CPU</sub> = 1/F <sub>CPU</sub>
SID171A	TDSO_EXT	MISO valid after SClk driving edge in Ext. Clk mode	–	–	48	ns	–
SID172	THSO	Previous MISO data hold time	0	–	–	ns	–
SID172A	TSSELSSCK	SSEL valid to first SCK valid edge	100	–	–	ns	–

#### Note

9. Guaranteed by characterization.

Electrical specifications

### 5.4.4 UART

**Table 22** UART DC specifications<sup>[10]</sup>

Spec ID#	Parameter	Description	Min	Typ	Max	Unit	Details/conditions
SID160	I <sub>UART1</sub>	Block current consumption at 100 Kbps	–	–	55	μA	–
SID161	I <sub>UART2</sub>	Block current consumption at 1000 Kbps	–	–	312	μA	–

**Table 23** UART AC specifications<sup>[10]</sup>

Spec ID#	Parameter	Description	Min	Typ	Max	Unit	Details/conditions
SID162	F <sub>UART</sub>	Bit rate	–	–	1	Mbps	–

### 5.4.5 LCD direct drive

**Table 24** LCD direct drive DC specifications<sup>[10]</sup>

Spec ID#	Parameter	Description	Min	Typ	Max	Unit	Details/conditions
SID155	C <sub>LDCAP</sub>	LCD capacitance per segment/common driver	–	500	5000	pF	–
SID156	LCD <sub>OFFSET</sub>	Long-term segment offset	–	20	–	mV	–
SID157	I <sub>LCDOP1</sub>	LCD system operating current V <sub>bias</sub> = 5 V	–	2	–	mA	32 × 4 segments at 50 Hz 25°C
SID158	I <sub>LCDOP2</sub>	LCD system operating current V <sub>bias</sub> = 3.3 V	–	2	–	mA	32 × 4 segments at 50 Hz 25°C

**Table 25** LCD direct drive AC specifications<sup>[10]</sup>

Spec ID#	Parameter	Description	Min	Typ	Max	Unit	Details/conditions
SID159	F <sub>LCD</sub>	LCD frame rate	10	50	150	Hz	–

**Note**

10. Guaranteed by characterization.

## 5.5 Memory

**Table 26 Flash DC specifications**

Spec ID#	Parameter	Description	Min	Typ	Max	Unit	Details/conditions
SID173	V <sub>PE</sub>	Erase and program voltage	1.71	–	5.5	V	–

**Table 27 Flash AC specifications**

Spec ID#	Parameter	Description	Min	Typ	Max	Unit	Details/conditions
SID174	T <sub>ROWWRITE</sub> <sup>[11]</sup>	Row (Block) write time (erase and program)	–	–	20	ms	Row (block) = 256 bytes
SID175	T <sub>ROWERASE</sub> <sup>[11]</sup>	Row erase time	–	–	16	ms	–
SID176	T <sub>ROWPROGRAM</sub> <sup>[11]</sup>	Row program time after erase	–	–	4	ms	–
SID178	T <sub>BULKERASE</sub> <sup>[11]</sup>	Bulk erase time (256 KB)	–	–	35	ms	–
SID180 <sup>[12]</sup>	T <sub>DEVPROG</sub> <sup>[11]</sup>	Total device program time	–	–	7	s	–
SID181 <sup>[12]</sup>	F <sub>END</sub>	Flash endurance	100 K	–	–	Cycles	–
SID182 <sup>[12]</sup>	F <sub>RET</sub>	Flash retention. T <sub>A</sub> ≤ 55°C, 100 K P/E cycles	20	–	–	Years	–
SID182A <sup>[12]</sup>	–	Flash retention. T <sub>A</sub> ≤ 85°C, 10 K P/E cycles	10	–	–	Years	–
SID182B	–	Flash retention. T <sub>A</sub> ≤ 105°C, 10K P/E cycles, ≤ three years at T <sub>A</sub> ≥ 85°C	10	–	20	Years	–
SID256	TWS48	Number of wait states at 48 MHz	2	–	–	–	CPU execution from Flash
SID257	TWS24	Number of wait states at 24 MHz	1	–	–	–	CPU execution from Flash

### Notes

11. It can take as much as 20 ms to write to flash. During this time the device should not be Reset, or Flash operations may be interrupted and cannot be relied on to have completed. Reset sources include the XRES pin, software resets, CPU lockup states and privilege violations, improper power supply levels, and watchdogs. Make certain that these are not inadvertently activated.

12. Guaranteed by characterization.



## 5.6 System resources

### 5.6.1 Power-on reset (POR)

**Table 28 Power-on reset (PRES)**

Spec ID#	Parameter	Description	Min	Typ	Max	Unit	Details/conditions
SID.CLK#6	SR_POWER_UP	Power supply slew rate	1	–	67	V/ms	At power-up and power-down
SID185 <sup>[13]</sup>	V <sub>RISEIPOR</sub>	Rising trip voltage	0.80	–	1.5	V	–
SID186 <sup>[13]</sup>	V <sub>FALLIPOR</sub>	Falling trip voltage	0.70	–	1.4	V	–

**Table 29 Brownout detect (BOD) for V<sub>CCD</sub>**

Spec ID#	Parameter	Description	Min	Typ	Max	Unit	Details/conditions
SID190 <sup>[13]</sup>	V <sub>FALLPPOR</sub>	BOD trip voltage in Active and Sleep modes	1.48	–	1.62	V	–
SID192 <sup>[13]</sup>	V <sub>FALLDPSLP</sub>	BOD trip voltage in Deep Sleep	1.11	–	1.5	V	–

### 5.6.2 SWD interface

**Table 30 SWD interface specifications**

Spec ID#	Parameter	Description	Min	Typ	Max	Unit	Details/conditions
SID213	F_SWDCCLK1	$3.3\text{ V} \leq V_{DD} \leq 5.5\text{ V}$	–	–	14	MHz	SWDCLK $\leq$ 1/3 CPU clock frequency
SID214	F_SWDCCLK2	$1.71\text{ V} \leq V_{DD} \leq 3.3\text{ V}$	–	–	7	MHz	SWDCLK $\leq$ 1/3 CPU clock frequency
SID215 <sup>[14]</sup>	T_SWDI_SETUP	$T = 1/f\text{ SWDCLK}$	0.25*T	–	–	ns	–
SID216 <sup>[14]</sup>	T_SWDI_HOLD	$T = 1/f\text{ SWDCLK}$	0.25*T	–	–	ns	–
SID217 <sup>[14]</sup>	T_SWDO_VALID	$T = 1/f\text{ SWDCLK}$	–	–	0.5*T	ns	–
SID217A <sup>[14]</sup>	T_SWDO_HOLD	$T = 1/f\text{ SWDCLK}$	1	–	–	ns	–

#### Notes

13. Guaranteed by characterization.  
 14. Guaranteed by design.

Electrical specifications

### 5.6.3 Internal Main Oscillator

**Table 31 IMO DC specifications**  
 (Guaranteed by design)

Spec ID#	Parameter	Description	Min	Typ	Max	Unit	Details/conditions
SID218	I <sub>IMO1</sub>	IMO operating current at 48 MHz	–	–	250	μA	–
SID219	I <sub>IMO2</sub>	IMO operating current at 24 MHz	–	–	180	μA	–

**Table 32 IMO AC specifications**

Spec ID#	Parameter	Description	Min	Typ	Max	Unit	Details/conditions
SID223 <sup>[16]</sup>	F <sub>IMOTOL1</sub>	Frequency variation at 24, 32, and 48 MHz (trimmed)	–	–	±2.0	%	At –40°C to 85°C, for industrial temperature range and original extended industrial range parts
SID223A <sup>[15, 16]</sup>			–	–	±2.5	%	At –40°C to 105°C, for all extended industrial temperature range parts
SID223B <sup>[15, 16]</sup>			–	–	±2.0	%	At –30°C to 105°C, for enhanced IMO extended industrial temperature range parts
SID223C <sup>[15, 16]</sup>			–	–	±1.5	%	At –20°C to 105°C, for enhanced IMO extended industrial temperature range parts
SID223D <sup>[15, 16]</sup>			–	–	±1.25	%	At 0°C to 85°C, for enhanced IMO extended industrial temperature range parts
SID226	T <sub>STARTIMO</sub>	IMO startup time	–	–	7	μs	–
SID228	T <sub>JITRMSIMO2</sub>	RMS jitter at 24 MHz	–	145	–	ps	–

**Notes**

15. The enhanced IMO extended temperature range parts replace the original extended industrial temperature range parts. For details on how to identify enhanced IMO extended temperature range parts, see to [KBA235887](#).

16. Evaluated by characterization. Does not take into account soldering or board-level effects.

Electrical specifications

### 5.6.4 Internal low-speed oscillator

**Table 33 ILO DC specifications**  
(Guaranteed by design)

Spec ID#	Parameter	Description	Min	Typ	Max	Unit	Details/conditions
SID231	I <sub>ILO1</sub>	ILO operating current	–	0.3	1.05	μA	–

**Table 34 ILO AC specifications**

Spec ID#	Parameter	Description	Min	Typ	Max	Unit	Details/conditions
SID234 <sup>[17]</sup>	T <sub>STARTILO1</sub>	ILO startup time	–	–	2	ms	–
SID236 <sup>[17]</sup>	T <sub>ILODUTY</sub>	ILO duty cycle	40	50	60	%	–
SID237	F <sub>ILOTRIM1</sub>	ILO frequency range	20	40	80	kHz	–

### 5.6.5 Watch crystal oscillator (WCO)

**Table 35 WCO specifications**

Spec ID#	Parameter	Description	Min	Typ	Max	Unit	Details/conditions
SID398	FWCO	Crystal frequency	–	32.768	–	kHz	–
SID399	FTOL	Frequency tolerance	–	50	250	ppm	With 20-ppm crystal
SID400	ESR	Equivalent series resistance	–	50	–	kΩ	–
SID401	PD	Drive level	–	–	1	μW	–
SID402	TSTART	Startup time	–	–	500	ms	–
SID403	CL	Crystal load capacitance	6	–	12.5	pF	–
SID404	C0	Crystal shunt capacitance	–	1.35	–	pF	–
SID405	IWCO1	Operating current (high power mode)	–	–	8	μA	–

### 5.6.6 External clock

**Table 36 External clock specifications**

Spec ID#	Parameter	Description	Min	Typ	Max	Unit	Details/conditions
SID305 <sup>[17]</sup>	ExtClkFreq	External clock input frequency	0	–	48	MHz	–
SID306 <sup>[17]</sup>	ExtClkDuty	Duty cycle; measured at V <sub>DD/2</sub>	45	–	55	%	–

### 5.6.7 External crystal oscillator and PLL

**Table 37 External crystal oscillator (ECO) specifications**

Spec ID#	Parameter	Description	Min	Typ	Max	Unit	Details/conditions
SID316 <sup>[17]</sup>	IECO1	Block current	–	–	1.5	mA	–
SID317 <sup>[17]</sup>	FECO	Crystal frequency range	4	–	33	MHz	–

**Note**

17. Guaranteed by design.

Electrical specifications

**Table 38 PLL specifications**

Spec ID#	Parameter	Description	Min	Typ	Max	Unit	Details/conditions
SID410	IDD_PLL_48	In = 3 MHz, Out = 48 MHz	–	530	610	µA	–
SID411	IDD_PLL_24	In = 3 MHz, Out = 24 MHz	–	300	405	µA	–
SID412	Fpllin	PLL input frequency	1	–	48	MHz	–
SID413	Fpllint	PLL intermediate frequency; prescaler out	1	–	3	MHz	–
SID414	Fppllvc	VCO output frequency before post-divide	22.5	–	104	MHz	–
SID415	Divvco	VCO Output post-divider range; PLL output frequency is Fppllvc/Divvco	1	–	8	–	–
SID416	Plllocktime	Lock time at startup	–	–	250	µs	–
SID417	Jperiod_1	Period jitter for VCO ≥ 67 MHz	–	–	150	ps	Guaranteed by design
SID416A	Jperiod_2	Period jitter for VCO ≤ 67 MHz	–	–	200	ps	Guaranteed by design

### 5.6.8 System clock

**Table 39 System clock specification**

Spec ID#	Parameter	Description	Min	Typ	Max	Unit	Details/conditions
SID262 <sup>[18]</sup>	T <sub>CLKSWITCH</sub>	System clock source switching time	3	–	4	Periods	–

### 5.6.9 Smart I/O

**Table 40 Smart I/O pass-through time (Delay in Bypass mode)**

Spec ID#	Parameter	Description	Min	Typ	Max	Unit	Details/conditions
SID252	PRG_BYPASS	Max delay added by Smart I/O in Bypass mode	–	–	1.6	ns	–

**Note**

18. Guaranteed by characterization.

Ordering information

## 6 Ordering information

The ordering information for the PSoC™ 4100S Plus 256 KB devices are listed in the following table.

**Table 41 Ordering information**

Category	Product	Max CPU Speed (MHz)	Features													Packages				Temp range (°C)
			Flash (KB)	SRAM (KB)	Opamp (CTBm)	CSD	10-bit CSD ADC	12-bit SAR ADC	SAR ADC sample rate	LP Comparators	TCPWM blocks	SCB blocks	ECO / PLL	Smart IOs	GPIO	48LD TQFP	64LD TQFP (0.5mm pitch)	64 lead TQFP (0.8mm pitch)	68 lead QFN	
4128	CY8C4128AZI-S443	24	256	32	2	-	1	1	806 Ksps	2	8	4	X	16	38	X	-	-	-	-40 to 85
	CY8C4128AZI-S445	24	256	32	2	-	1	1	806 Ksps	2	8	5	X	16	54	-	X	-	-	-40 to 85
	CY8C4128AXI-S445	24	256	32	2	-	1	1	806 Ksps	2	8	5	X	16	54	-	-	X	-	-40 to 85
	CY8C4128AZI-S453	24	256	32	2	1	1	1	806 Ksps	2	8	4	X	16	38	X	-	-	-	-40 to 85
	CY8C4128AZI-S455	24	256	32	2	1	1	1	806 Ksps	2	8	5	X	16	54	-	X	-	-	-40 to 85
	CY8C4128AXI-S455	24	256	32	2	1	1	1	806 Ksps	2	8	5	X	16	54	-	-	X	-	-40 to 85
4148	CY8C4148AZI-S443	48	256	32	2	-	1	1	1 Msps	2	8	4	X	16	38	X	-	-	-	-40 to 85
	CY8C4148AZQ-S443	48	256	32	2	-	1	1	1 Msps	2	8	4	X	16	38	X	-	-	-	-40 to 105
	CY8C4148AZI-S445	48	256	32	2	-	1	1	1 Msps	2	8	5	X	16	54	-	X	-	-	-40 to 85
	CY8C4148AZQ-S445	48	256	32	2	-	1	1	1 Msps	2	8	5	X	16	54	-	X	-	-	-40 to 105
	CY8C4148AXI-S445	48	256	32	2	-	1	1	1 Msps	2	8	5	X	16	54	-	-	X	-	-40 to 85
	CY8C4148AXQ-S445	48	256	32	2	-	1	1	1 Msps	2	8	5	X	16	54	-	-	X	-	-40 to 105
	CY8C4148AZI-S453	48	256	32	2	1	1	1	1 Msps	2	8	4	X	16	38	X	-	-	-	-40 to 85
	CY8C4148AZQ-S453	48	256	32	2	1	1	1	1 Msps	2	8	4	X	16	38	X	-	-	-	-40 to 105
	CY8C4148AZI-S455	48	256	32	2	1	1	1	1 Msps	2	8	5	X	16	54	-	X	-	-	-40 to 85
	CY8C4148AZQ-S455	48	256	32	2	1	1	1	1 Msps	2	8	5	X	16	54	-	X	-	-	-40 to 105
	CY8C4148AXI-S455	48	256	32	2	1	1	1	1 Msps	2	8	5	X	16	54	-	-	X	-	-40 to 85
	CY8C4148AXQ-S455	48	256	32	2	1	1	1	1 Msps	2	8	5	X	16	54	-	-	X	-	-40 to 105

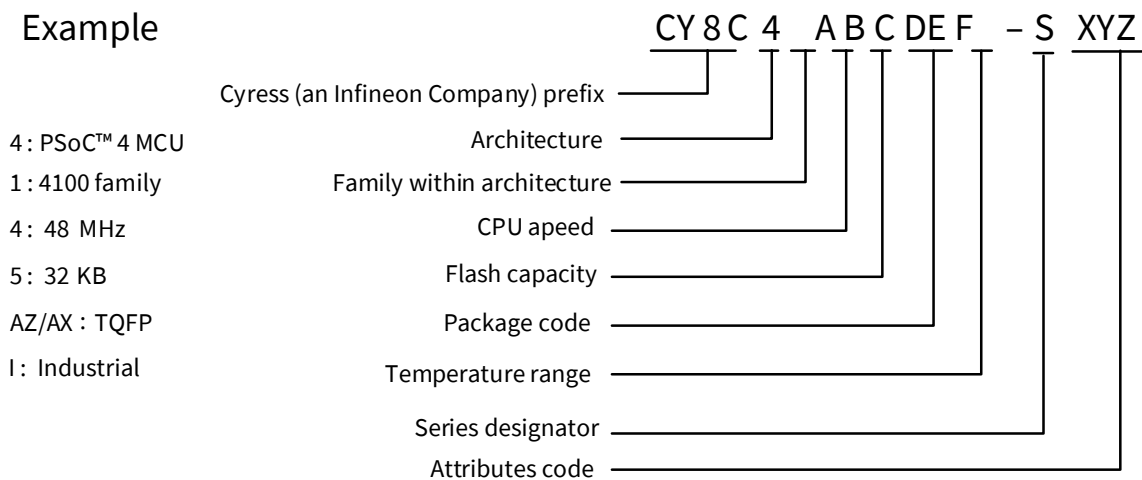
Ordering information

The nomenclature used in the preceding table is based on the following part numbering convention:

Field	Description	Values	Meaning
CY8C	Infineon prefix		
4	Architecture	4	PSoC™ 4 MCU
A	Family	1	4100 family
B	CPU speed	2	24 MHz
		4	48 MHz
C	Flash capacity	4	16 KB
		5	32 KB
		6	64 KB
		7	128 KB
DE	Package code	AX	TQFP (0.8-mm pitch)
		AZ	TQFP (0.5-mm pitch)
		LQ	QFN
		PV	SSOP
		FN	CSP
F	Temperature range	I	Industrial
		Q	Extended Industrial
S	Series designator	S	PSoC™ 4 S-series
		M	PSoC™ 4 M-series
		L	PSoC™ 4 L-series
		BL	PSoC™ 4 Bluetooth® LE-series
XYZ	Attributes code	000-999	Code of feature set in the specific family

The following is an example of a part number:

**Example**



## 7 Packaging

The PSoC™ 4100S Plus 256 KB is offered in 48LD TQFP, 64LD TQFP Normal pitch, 64 leadTQFP fine pitch packages, and 68 lead QFN packages.

Package dimensions and Infineon drawing numbers are in the following table.

**Table 42 Package list**

Spec ID#	Package	Description	Package dwg
BID20	64 lead TQFP	14 × 14 × 1.4-mm height with 0.8-mm pitch	51-85046
BID27	64LD TQFP	10 × 10 × 1.4-mm height with 0.5-mm pitch	51-85051
BID70	48LD TQFP	7 × 7 × 1.4-mm height with 0.5-mm pitch	51-85135
BID71	68 lead QFN	8 × 8 × 0.9-mm height with 0.5-mm pitch	002-15530

**Table 43 Package thermal characteristics**

Parameter	Description	Package	Min	Typ	Max	Unit
T <sub>A</sub>	Operating ambient temperature	–	–40	25	105	°C
T <sub>J</sub>	Operating junction temperature	–	–40	–	125	°C
T <sub>JA</sub>	Package θ <sub>JA</sub>	64LD TQFP (0.5-mm pitch)	–	46	–	°C/Watt
T <sub>JC</sub>	Package θ <sub>JC</sub>	64LD TQFP (0.5-mm pitch)	–	10	–	°C/Watt
T <sub>JA</sub>	Package θ <sub>JA</sub>	64 lead TQFP (0.8-mm pitch)	–	36.8	–	°C/Watt
T <sub>JC</sub>	Package θ <sub>JC</sub>	64 lead TQFP (0.8-mm pitch)	–	9.4	–	°C/Watt
T <sub>JA</sub>	Package θ <sub>JA</sub>	48LD TQFP (0.5-mm pitch)	–	39.4	–	°C/Watt
T <sub>JC</sub>	Package θ <sub>JC</sub>	48LD TQFP (0.5-mm pitch)	–	9.3	–	°C/Watt
T <sub>JA</sub>	Package θ <sub>JA</sub>	68 lead QFN (0.5-mm pitch)	–	21	–	°C/Watt
T <sub>JC</sub>	Package θ <sub>JC</sub>	68 lead QFN (0.5-mm pitch)	–	8.8	–	°C/Watt

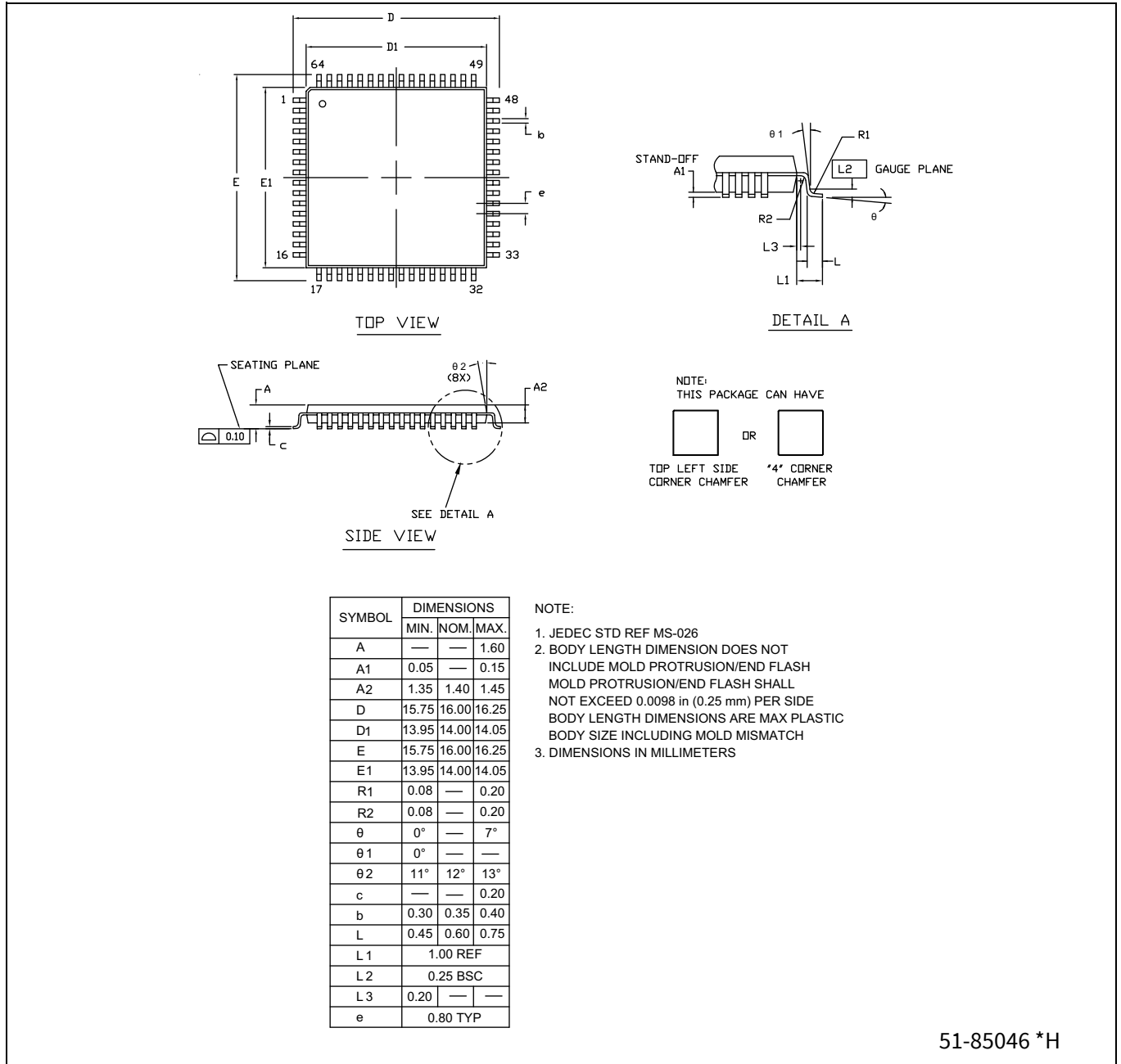
**Table 44 Solder reflow peak temperature**

Package	Maximum peak temperature	Maximum time at peak temperature
All	260°C	30 s

**Table 45 Package moisture sensitivity level (MSL), IPC/JEDEC J-STD-020**

Package	MSL
All	MSL 3

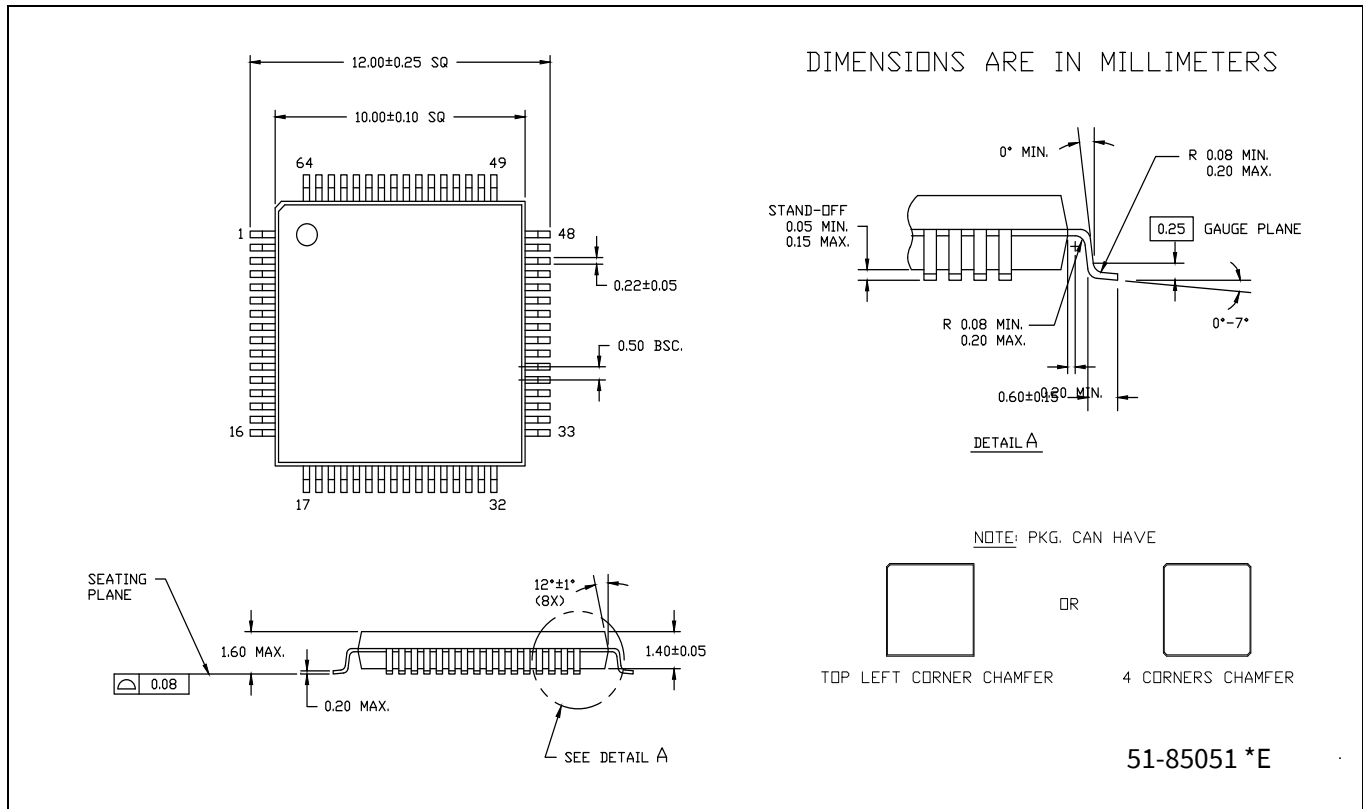
## 7.1 Package diagrams



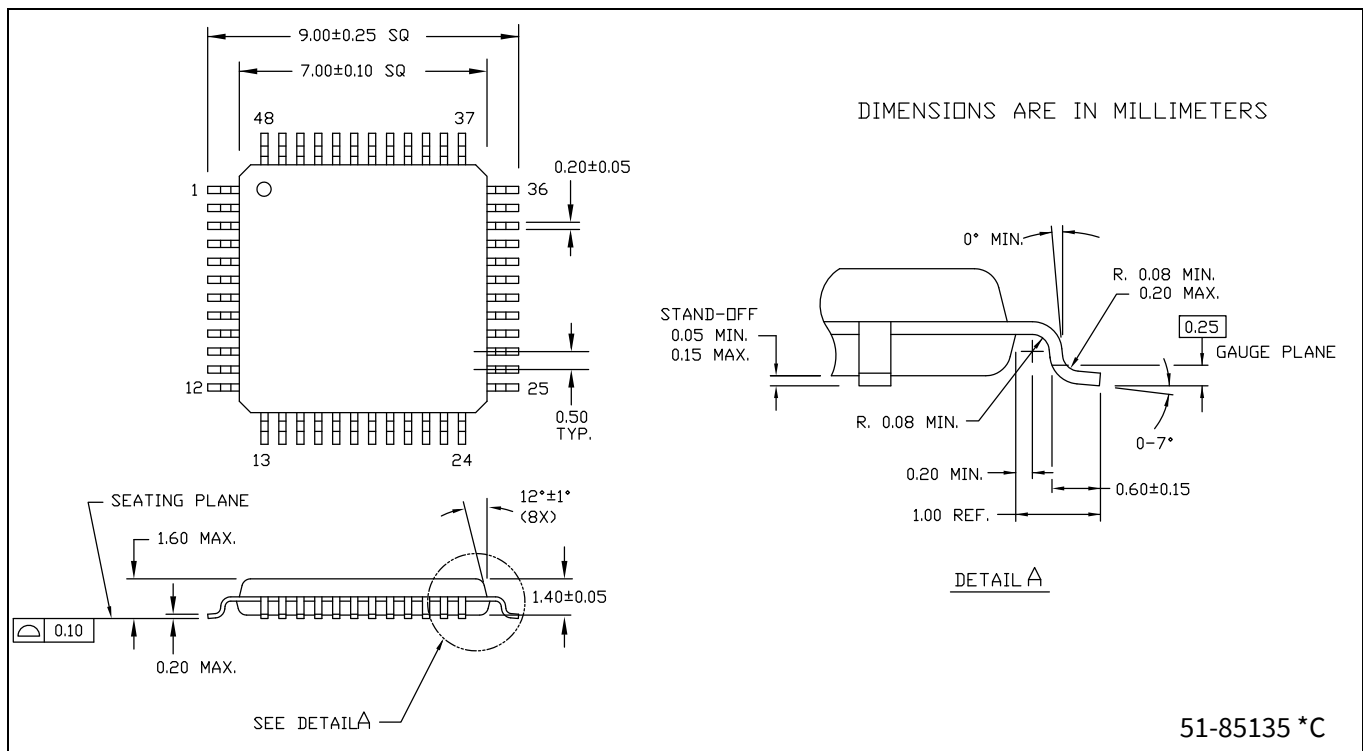
**Figure 7** 64 lead TQFP 14.0×14.0×1.4 MM A64SA, package outline (PG-TQFP-64)



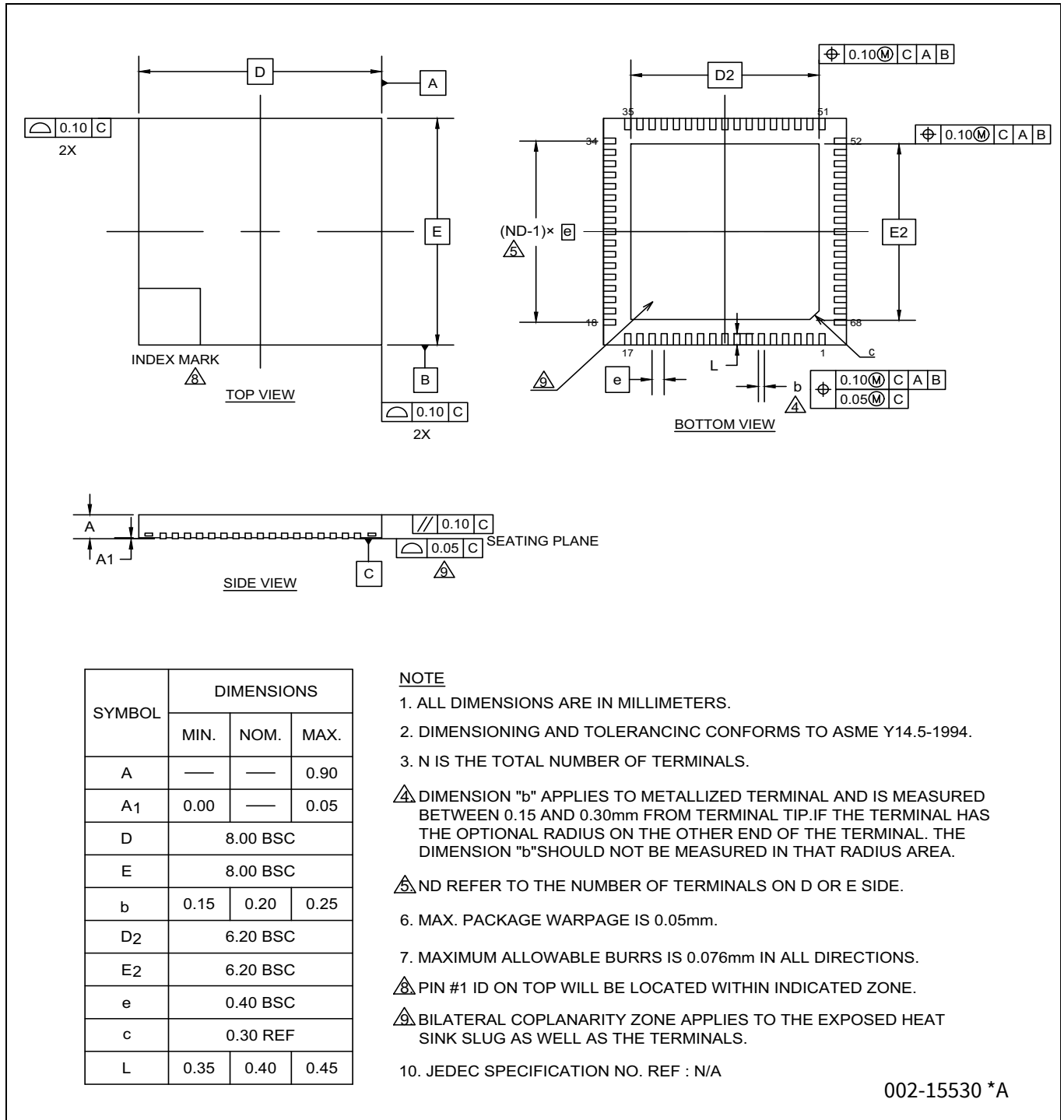
Packaging



**Figure 8 64LD TQFP 10×10×1.4 MM A64SB, package outline (PG-TQFP-64)**



**Figure 9 48LD TQFP 7×7×1.4 MM A48, package outline (PG-TQFP-48)**



**Figure 10** 68 lead QFN 8.0×8.0×0.9 MM VNB068/LT68E 6.2×6.2 MM EPAD (SAWN), package outline (PG-VQFN-68)

## 8 Acronyms/abbreviations

**Table 46** Acronyms/abbreviations

<b>Acronym</b>	<b>Description</b>
ABUS	analog local bus
ADC	Analog-to-Digital Converter
AG	analog global
ALU	arithmetic logic unit
AMUXBUS	Analog multiplexer bus
API	Application Programming Interface
APSR	application program status register
Arm®	Advanced RISC Machine, a CPU architecture
ATM	Automatic Thump Mode
BW	bandwidth
CAN	Controller Area Network, a communications protocol
CMRR	common-mode rejection ratio
CPU	Central Processing Unit
CRC	cyclic redundancy check, an error-checking protocol
DAC	digital-to-analog converter, see also IDAC, VDAC
DFB	digital filter block
DIO	digital input/output, GPIO with only digital capabilities, no analog. See GPIO.
DMIPS	Dhrystone Million Instructions per Second
DMA	Direct Memory Access, see also TD
DNL	differential nonlinearity, see also INL
DNU	Do Not Use
DR	Port Write Data Registers
DSI	digital system interconnect
DWT	data watchpoint and trace
ECC	error correcting code
ECO	external crystal oscillator
EEPROM	electrically erasable programmable read-only memory
EMI	electromagnetic interference
EMIF	External Memory Interface
EOC	end of conversion
EOF	end of frame
EPSR	execution program status register
ESD	electrostatic discharge
ETM	embedded trace macrocell
FIR	finite impulse response, see also IIR
FPB	flash patch and breakpoint
FS	Full Speed

Acronyms/abbreviations

**Table 46** Acronyms/abbreviations (continued)

Acronym	Description
GPIO	general-purpose input/output, applies to a PSoC™ pin
HVI	high-voltage interrupt, see also LVI, LVD
IC	integrated circuit
IDAC	current DAC, see also DAC, VDAC
IDE	integrated development environment
I <sup>2</sup> C, or IIC	inter-integrated circuit, a communications protocol
IIR	infinite impulse response, see also FIR
ILO	internal low-speed oscillator, see also IMO
IMO	internal main oscillator, see also ILO
INL	integral nonlinearity, see also DNL
I/O	input/output, see also GPIO, DIO, SIO, USBIO
IPOR	initial power-on reset
IPSR	Interrupt Program Status Register
IRQ	interrupt request
ITM	instrumentation trace macrocell
LCD	liquid crystal display
LIN	Local Interconnect Network, a communications protocol.
LR	Link register
LUT	lookup table
LVD	low-voltage detect, see also LVI
LVI	low-voltage interrupt, see also HVI
LVTTL	low-voltage transistor-transistor logic
MAC	multiply-accumulate
MCU	microcontroller unit
MISO	master-in slave-out
NC	no connect
NMI	nonmaskable interrupt
NRZ	non-return-to-zero
NVIC	nested vectored interrupt controller
NVL	nonvolatile latch, see also WOL
opamp	operational amplifier
PAL	programmable array logic, see also PLD
PC	program counter
PCB	printed circuit board
PGA	programmable gain amplifier
PHUB	peripheral hub
PHY	physical layer
PICU	port interrupt control unit
PLA	programmable logic array
PLD	programmable logic device, see also PAL

Acronyms/abbreviations

**Table 46** Acronyms/abbreviations (continued)

Acronym	Description
PLL	phase-locked loop
PMDD	package material declaration data sheet
POR	power-on reset
PRES	precise power-on reset
PRS	pseudo random sequence
PS	port read data register
PSoC™	programmable system on chip
PSRR	power supply rejection ratio
PWM	pulse-width modulator
RAM	random-access memory
RISC	reduced-instruction-set computing
RMS	root-mean-square
RTC	real-time clock
RTL	register transfer language
RTR	remote transmission request
RX	receive
SAR	successive approximation register
SC/CT	switched capacitor/continuous time
SCL	I <sup>2</sup> C serial clock
SDA	I <sup>2</sup> C serial data
S/H	sample and hold
SINAD	signal to noise and distortion ratio
SIO	special input/output, GPIO with advanced features. See GPIO.
SOC	start of conversion
SOF	start of frame
SPI	Serial Peripheral Interface, a communications protocol
SR	slew rate
SRAM	static random access memory
SRES	software reset
SWD	serial wire debug, a test protocol
SWV	single-wire viewer
TD	transaction descriptor, see also DMA
THD	total harmonic distortion
TIA	transimpedance amplifier
TTL	transistor-transistor logic
TX	transmit
UART	Universal Asynchronous Transmitter Receiver, a communications protocol
UDB	universal digital block
USB	Universal Serial Bus
USBIO	USB input/output, PSoC™ pins used to connect to a USB port

**Table 46**      **Acronyms/abbreviations** *(continued)*

<b>Acronym</b>	<b>Description</b>
VDAC	voltage DAC, see also DAC, IDAC
WDT	watchdog timer
WOL	write once latch, see also NVL
WRES	watchdog timer reset
XRES	external reset I/O pin
XTAL	crystal

## 9 Document conventions

### 9.1 Units of measure

**Table 47** Units of measure

Symbol	Unit of measure
°C	degrees celsius
dB	decibel
fF	femto farad
Hz	hertz
KB	1024 bytes
kbps	kilobits per second
Khr	kilohour
kHz	kilohertz
kΩ	kilo ohm
ksps	kilosamples per second
LSB	least significant bit
Mbps	megabits per second
MHz	megahertz
MΩ	mega-ohm
Msps	megasamples per second
μA	microampere
μF	microfarad
μH	microhenry
μs	microsecond
μV	microvolt
μW	microwatt
mA	milliampere
ms	millisecond
mV	millivolt
nA	nanoampere
ns	nanosecond
nV	nanovolt
Ω	ohm
pF	picofarad
ppm	parts per million
ps	picosecond
s	second
sps	samples per second
sqrtHz	square root of hertz
V	volt

## Revision history

Document version	Date of release	Description of changes
*B	2020-03-18	Release to web.
*C	2020-11-10	Added ModusToolbox™ in <b>Features</b> . Updated <b>Development ecosystem</b> . Added <b>ModusToolbox™ software</b> . Updated <b>Table 27</b> : Updated SID182B. Updated <b>Table 32</b> : Added SID223A. Updated <b>Ordering information</b> .
*D	2022-07-26	Updated <b>Table 32</b> : Updated spec SID223 and SID223A. Added specs SID223B through SID223D. Migrated to Infineon template.
*E	2023-01-24	Updated the footnotes in <b>IMO AC specifications</b> .
*F	2023-04-26	Added 68 LEAD QFN in <b>“Pinouts”</b> on page 13 and updated GPIO by package. Added 68 LEAD QFN in the section <b>“Ordering information”</b> on page 44. Updated <b>Table 42</b> and <b>Table 43</b> with 68-pin QFN. Added title for <b>Figure 10</b> . Updated the pin list in description of <b>Pinouts</b> and <b>Packaging</b> . Added the Package information for 68 LEAD QFN in Table 42. Updated 54 GPIO to 57 GPIO throughout the document.
*G	2024-03-08	Fixed broken links. Updated packaging diagram titles with IFX package code for <b>Figure 7</b> , <b>Figure 8</b> , <b>Figure 9</b> , and <b>Figure 10</b> . Updated <b>Figure 8</b> : 51-85051 *D to 51-85051 *E. Updated package information in <b>Table 41</b> , <b>Table 42</b> , and <b>Table 43</b> . Updated package information across the datasheet. Removed part numbers CY8C4128LQI-S446, CY8C4128LQQ-S456, CY8C4148LQI-S446, and CY8C4148LQQ-S456 from <b>Table 41</b> .



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